REPORT ON
Radio testing of the VERTEX STANDARD VX-P829-G7-5
In accordance with ANSI/TIA/EIA-603, RSS-119

Report number TA000465 March 2007

GENERAL INFORMATION

MODEL NAME:	VX-P829-G7-5	
FCC ID:	K6610584821	
IC ID:	511B-10584821	
MANUFACTURER:	Vertex Standard Co., Ltd.	
TRADE NAME:	VERTEX STANDARD	
EUT DESCRIPTION:	UHF FM Transceiver	
SERIAL NUMBER:	6N000007	
VOLTAGE RQUIREMENTS:	7.4 DC	[V]
NUMBER OF CHANNELS:	512	
SPECIFICATION ARE REFERENCE	ANSI/TIA/EIA-603 RSS-119	

TRANSMITTERS

TYPE OF EMISSION:	16K0F3E/11K0F3E/8K10F1E/8K10F1D	
FREQUENCY RANGE:	450 to 512	[MHz]
POWER OUTPUT RATING:	1 to 5 __ Switchable x Variable __ N/A	[W]
MAXIMUM POWER RATING:	300	[W]
INPUT IMPEDANCE (MIC):	2000	[Ω]
OUTPUT IMPEDANCE (RF):	50	[Ω]
Collector Voltage:	7.4	[V]
Collector Current:	1.3	[A]

RECEIVERS

FREQUENCY RANGE:	450 to 512	[MHz]
INTERMEDIATE FREQUENCIES:	1st -50.85 2nd 450	[MHz] [kHz]
INPUT IMPEDANCE (RF):	50	[Ω]
OUTPUT IMPEDANCE (SP):	16	[Ω]
AUDIO OUTPUT POWER:	0.7	[W]

This report was prepared by Vertex Standard Co., Ltd.

Test performed by M.Kurihara

Date 02 / March /2007

VX-P829-G7-5 Channel Settings

Group 01

CH No.	Shown on LCD	Transmit Frequency [MHz]	Receive Frequency [MHz]	CH Spacing	Power	
					High	Low
1	450M WH	450.000	450.000	25k	5W	
2	455M WH	455.000	455.000	25k	5W	
3	512M WH	512.000	512.000	25k	5W	
4	450M NH	450.000	450.000	12.5k	5W	
5	455M NH	455.000	455.000	12.5k	5W	
6	512M NH	512.000	512.000	12.5k	5W	
7	450M WL	450.000	450.000	25k		1W
8	455M WL	455.000	455.000	25k		1W
9	512M WL	512.000	512.000	25k		1W
10	450M NL	450.000	450.000	12.5k		1W
11	455M NL	455.000	455.000	12.5k		1W
12	512M NL	512.000	512.000	12.5k		1W
13						
14						
15						
16						

Group 02 (*)

CH No.	Shown on LCD	Transmit Frequency [MHz]	Receive Frequency [MHz]	CH Spacing	Power	
					High	Low
17	450MHz D	450.000	450.000	Digital	5W	
18	455MHz D	455.000	455.000	Digital	5W	
19	512MHz D	512.000	512.000	Digital	5W	
20	450MHz D_L	450.000	450.000	Digital		1W
21	455MHz D_L	455.000	455.000	Digital		1W
22	512MHz D_L	512.000	512.000	Digital		1W
23						
24						
25						
26						
27						
28						
29						
30						
31						
32						

NAME OF TEST: R.F. Power Output (Conducted)
SPECIFICATION: 47 CFR 2.1046 (a)
GUIDE: ANSI/TIA/EIA-603, Paragraph 2.2.1
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the modulated output powerwas measured by means of an R.F. power meter.

2. Measurement accuracy is ± 4%

MEASUREMENT RESULTS

NOMINAL, MHz	CHANNEL	R.F. POWER, WATTS	
		LOW	HIGH
450.000	1	0.860	5.170
455.000	2	0.890	5.240
512.000	3	1.160	4.950

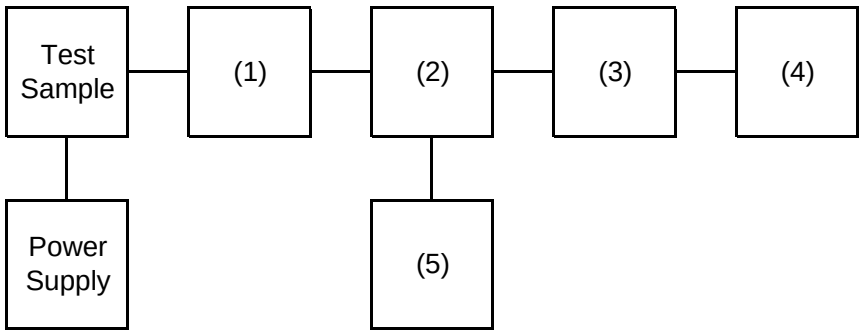
NAME OF TEST: R.F. Power Output (Radiated)

High Power

FREQUENCY TUNED, MHz	LEVEL, dBm
450.0000	35.9
455.0000	37.9
512.0000	38.0

TRANSMITTER POWER CONDUCTED MEASUREMENTS

TEST 1: R.F. POWER OUTPUT
TEST 2: FREQUENCY STABILITY



Instruments	Description	Serial Number
(1) COAXUAL ATTENUATOR	WEINSCHELL 49-10-43	***
(2) RF COUPLER	ADVANTEST TR4153	***
(3) POWER SENSOR	Agilent 8482B	***
(4) POWER METER	Agilent 8901B POWER MODE	***
(5) FREQUENCY COUNTER	gilent 8901B FREQUENCY MOI	***

NAME OF TEST:	Unwanted Emissions (Conducted)
SPECIFICATION:	47 CFR 2.1051
GUIDE:	ANSI/TIA/EIA-603, Paragraph 2.2.13
TEST EQUIPMENT:	As per attached page

MEASUREMENT PROCEDURE

1. The emissions were measured for the worst case as follows:
   (a): within a band of frequencies defined by the carrier frequency plus and minus one channel.
   (b): from the lowest frequency generated in the EUT and to at least the 10th harmonic of the carrier frequency, or 40GHz, whichever is lower.

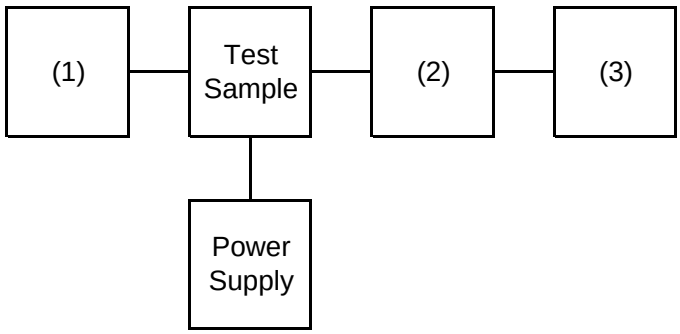
2. The magnitude of spurious emissions that are attenuated more than 20dB below the permissible value need not be specified.

3. MEASUREMENT RESULTS:

FREQUENCY OF CARRIER, MHz	=	450 , 455 , 512
SPECTRUM SEARCHED, GHz	=	0 to 10 x Fc
MAXIMUM RESPONSE, Hz	=	3000
ALL OTHER EMISSIONS	=	>= 20dB BELOW LIMIT

TRANSMITTER SPURIOUS EMISSION

TEST 1: OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
TEST 2: OUT-OF-BAND SPURIOUS



Instruments	Description	Serial Number
(1) AUDIO GENERATOR	Agilent 8903B	***
(2) COAXUAL ATTENUATOR	WEINSCHELL 49-10-43	***
(2) COAXUAL ATTENUATOR	Agilent 8498A	***
(3) SPECTRUM ANALYZER	ADVANTEST TR4173	***

NAME OF TEST: Unwanted Emissions (Conducted)

LIMIT'S), dBc: -(50+10xLOG(P) = -57 (5 Watts)
-(50+10xLOG(P) = -50 (1 Watts)

High Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
450.0000	900.0000	-39.9	-76.9	19.9

NAME OF TEST: Unwanted Emissions (Conducted)

LIMIT'S), dBc: -(50+10xLOG(P) = -57 (5 Watts)
-(50+10xLOG(P) = -50 (1 Watts)

Low Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
450.0000	900.0000	-40.0	-70.0	20.0

NAME OF TEST: Field Strength of Spurious Radiation
SPECIFICATION: 47 CFR 2.1053 (a)
GUIDE: ANSI/TIA/EIA-603, Paragraph 1.2.12

MEASUREMENT PROCEDURE

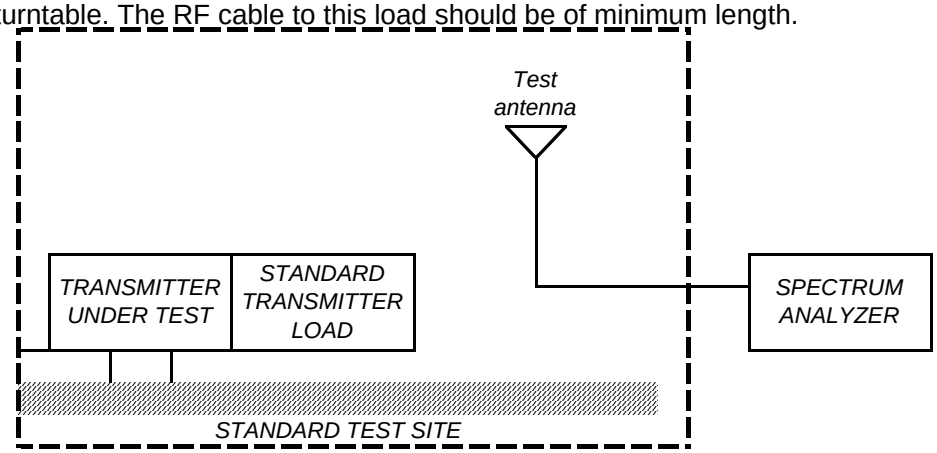
1.2.12. Definition: Radiated spurious emissions are emissions from the equipment when transmitting load on a frequency or frequencies which are outside an occupied ba sufficient to ensure transmission of information of required quality for the class of communications desired.

1.2.12. Method of measurement

A) Connect the equipment as illustrated.

B) Adjust the spectrum analyzer for the following settings:
1) Resolution Bandwidth <= 3kHz
2) Video Bandwidth >= 10kHz
3) Sweep Speed <= 2000Hz/second
4) Detector Mode = Positive Peak

C) Place the transmitter to be tested on the turntable in the standard test site. The transmitter is transmitting into a non-radiating load which is placed on the turntable. The RF cable to this load should be of minimum length.

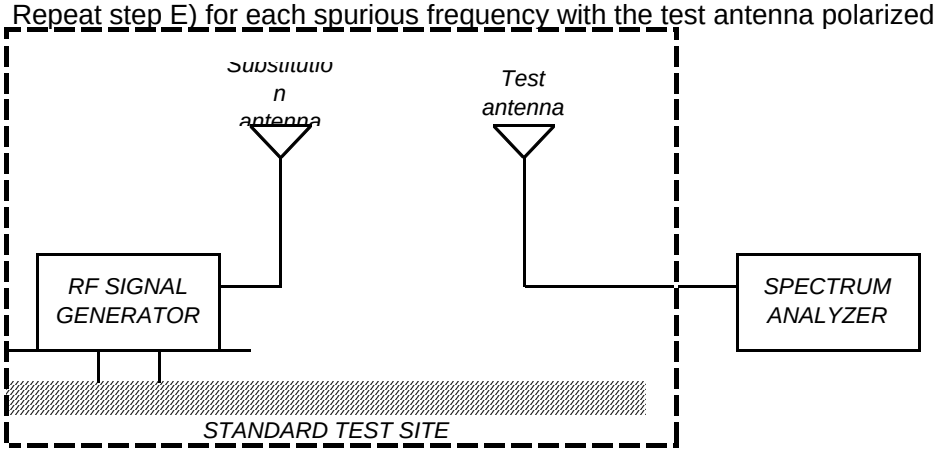


D) For each spurious measurment the test antenna should be adjusted to the correct length for the frequency involved. This length maybe determined from a calibratio ruler supplied with the equipment. Measurements shall be made from the lowest radio frequency generated in the equipment to the tenth harmonic of the carrier, except for the region close to the carrier qeual to ± the test bandwidth (see section 1.3.4.4).

E) For each spurious frequency, raise and lower the test antenna from 1 m to 4 m to obtain a maximum reading on the spectrum analyzer with the test antenna at horizontal polarity.

NAME OF TEST: Field Strength of Spurious Radiation

F) Repeat step E) for each spurious frequency with the test antenna polarized ver



G) Reconnect the equipment as illustrated.

H) Keep the spectrum analyzer adjusted as in step B).

I) Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved).
The center of the substitutuion antenna should be approximately at the same loca as the center of the transmitter. At lower frequencies, where the substitution anter is very long, this will be impossible to achieve when the antenna is plarized vertica In such case the lower end of the antenna should be 0.3m above the ground

J) Feed the substitution antenna at the transmitter end with a signal generator conne to the antenna by means of a non-radiating cable. With the antennas at both ends horizontally polarized and with the signal generator tuned to a particular spurious frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output untill the previusl recorded maximum reading for the set of conditions is obtained. This sho be done carefully repeating the adjustment of the test antenna and generator outp

K) Repeat step J) with both antennas vertically polarized for each spurious frequency

L) Calculate power in dBm into a reference ideal half-wave dipole antenna by reduci the readings obtained in step J) and K) by the power loss in the cable between the generator and the antenna and futher corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna

M) The levels recorded in step L) are absolute levels of radiated spurious emissions in dBm. The radiated spurious emissions in dB can be calculated by the following

Radiated spurious emissions dB = 10log(TX power in watts/0.001) - the levels in step L)

NAME OF TEST: Field Strength of Spurious Radiation

Note: It is permissible that other antennas provided can be referenced to a dipole.

Instruments	Description	Serial Number
TRANSDUCER	Schaffner-Chase CBL6143	***
TRANSDUCER	EMCO 3115	***
AMPLIFIER	Agilent 8447D	***
AMPLIFIER	Agilent 8449B	***
SPECTRUM ANALYZER	Agilent 8561B	***

NAME OF TEST: Field Strength of Spurious Radiation

LIMIT'S), dBc: -(50+10xLOG(P) = -57 (5 Watts)
-(50+10xLOG(P) = -50 (1 Watts)

High Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	C.F., dB	ERP, dBm	ERP, dBc
450.0000	1350.0000	78.1	-0.6	-29.5	-66.5
455.0000	1365.0000	75.4	0.6	-31.0	-68.0
512.0000	2560.0000	65.7	9.6	-31.7	-68.7
512.0000	3072.0000	61.1	13.6	-32.3	-69.3

NAME OF TEST: Field Strength of Spurious Radiation

LIMIT'S), dBc: -(50+10xLOG(P) = -57 (5 Watts)
-(50+10xLOG(P) = -50 (1 Watts)

Low Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	C.F., dB	ERP, dBm	ERP, dBc
450.0000	900.0000	42.4	32.3	-32.3	-62.3
455.0000	910.0000	41.5	31.4	-34.1	-64.1
512.0000	1024.0000	38.5	30.0	-38.5	-68.5

NAME OF TEST:	Emission Masks (Occupied Bandwidth)
SPECIFICATION:	47 CFR 2.1049 (c) (1)
GUIDE:	ANSI/TIA/EIA-603, Paragraph 2.2.11
TEST EQUIPMENT:	As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment ware set up as shown on the following page, with the spectrum analyzer connected.

2. For EUT's supporting audio modulation, the audio signal generator was adjustec to the frequency of maxmum response and with output level set for ±2.5/±1.5kHz deviation (or 50% modulation). With level constant, the signal level was increasec 16dB.

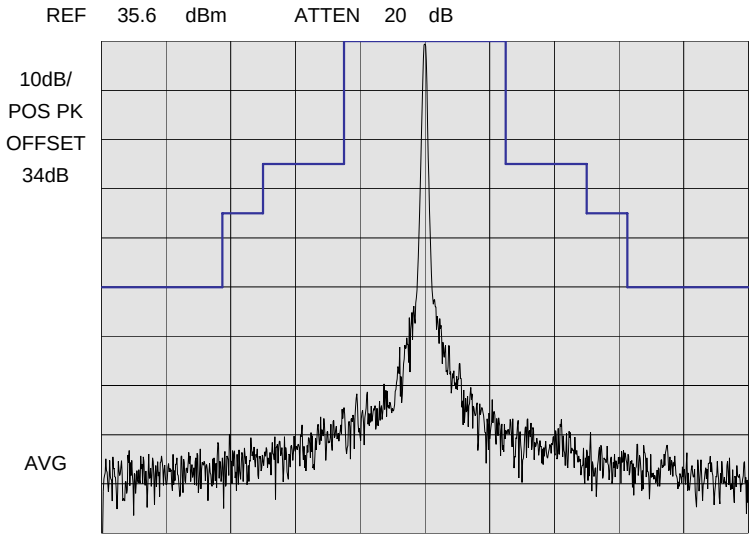
3. For EUT's supporting digital modulation, the digital modulation mode was operate to its maximum extent.

4. The occupied bandwidth was measured with the spectrum analyzer controls set a shown on the test results.

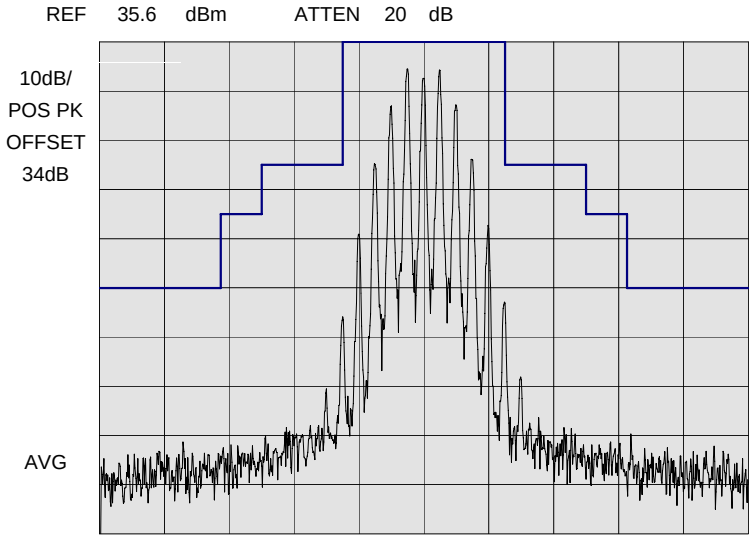
5. MEASUREMENT RESULTS: ATTACHED

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



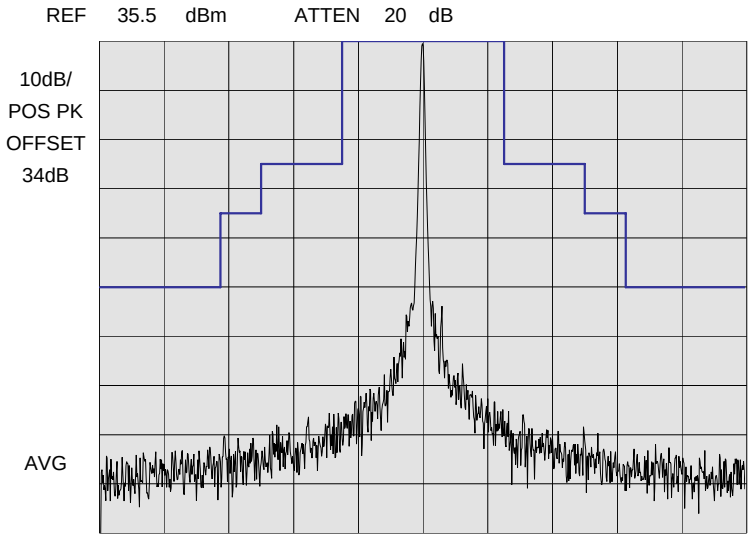
Power: High
Modulation: None
25 kHz, MASK B



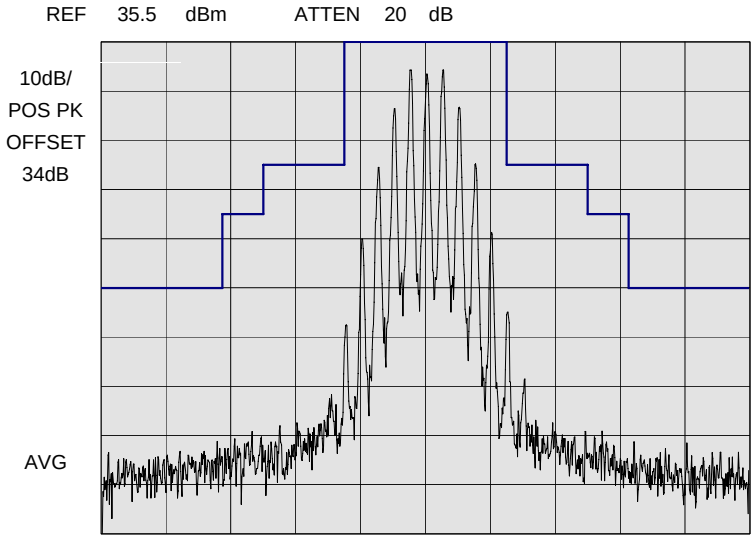
Power: High
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



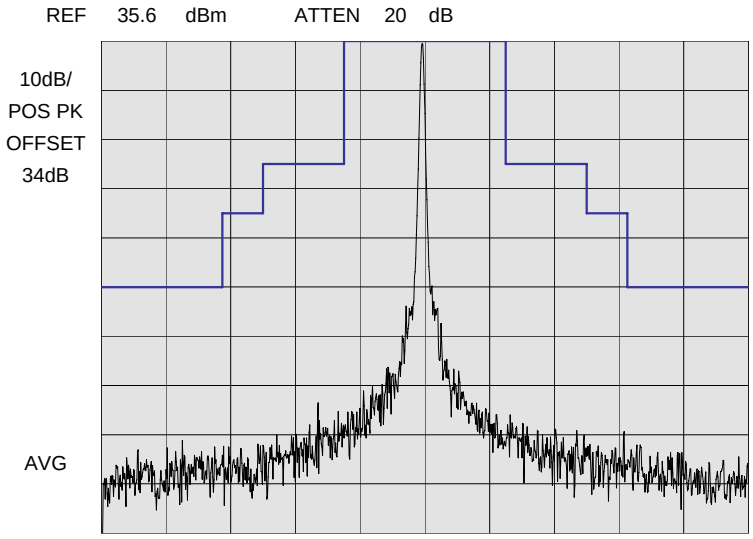
Power: High
Modulation: None
25 kHz, MASK B



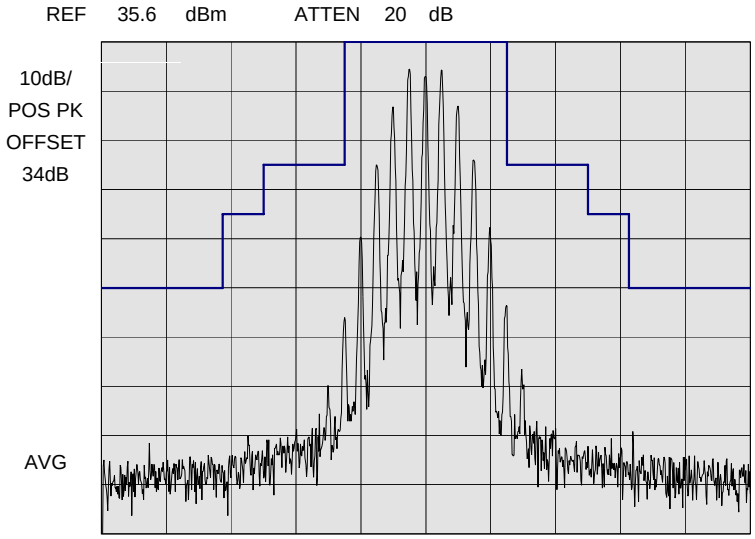
Power: High
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



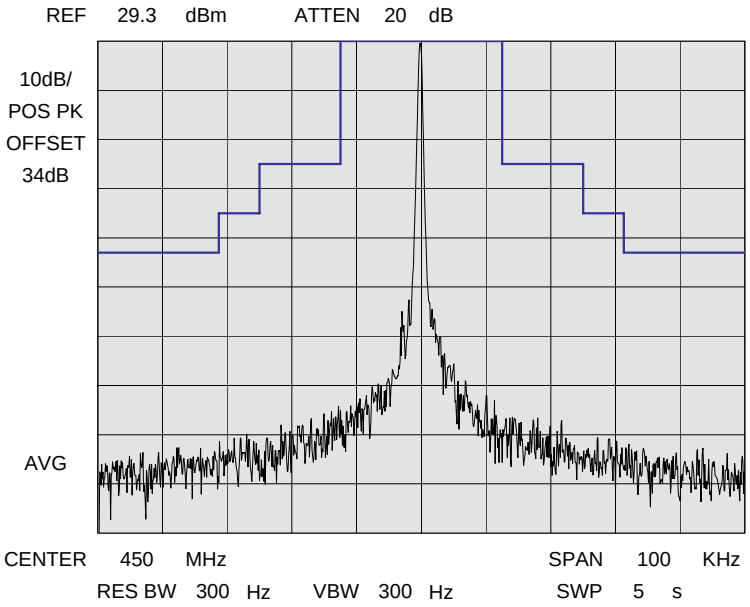
Power: High
Modulation: None
25 kHz, MASK B



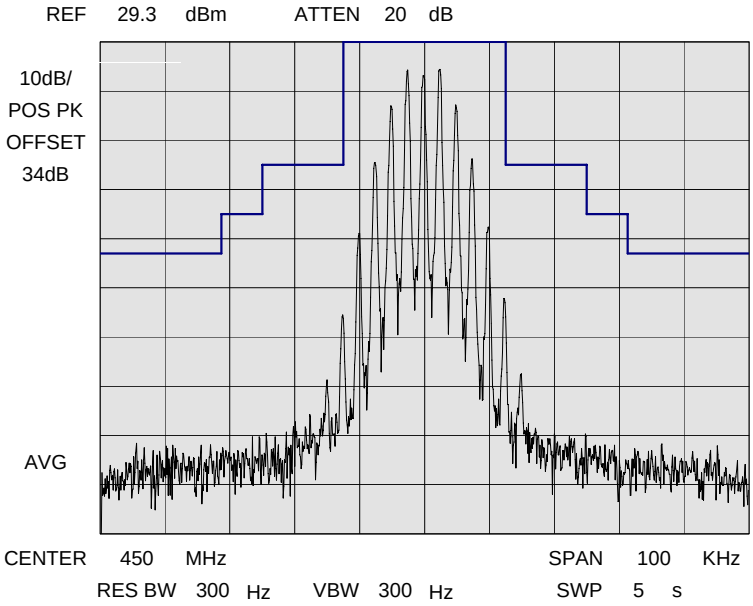
Power: High
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



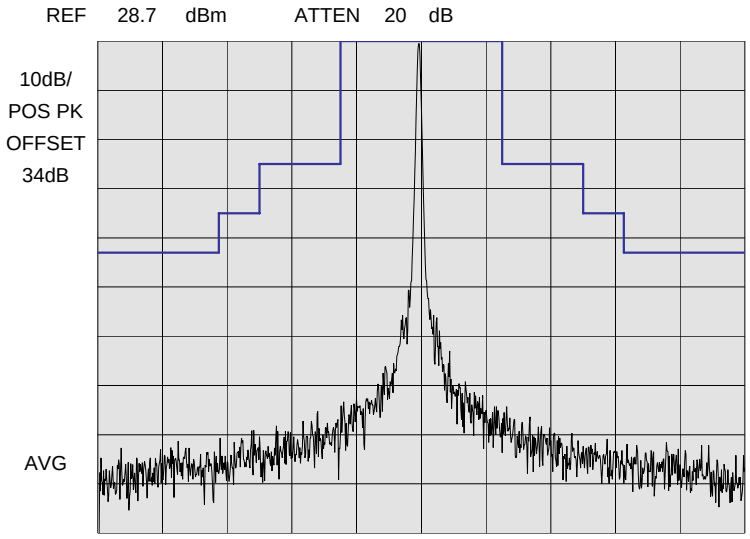
Power: Low
Modulation: None
25 kHz, MASK B



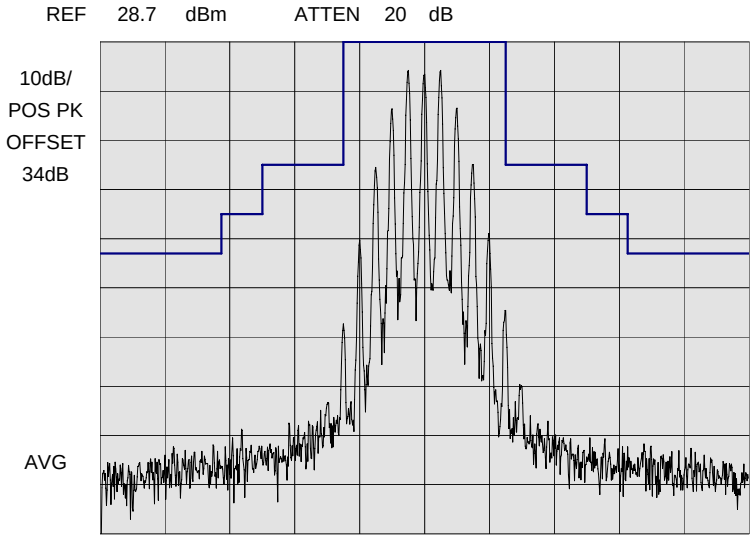
Power: Low
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



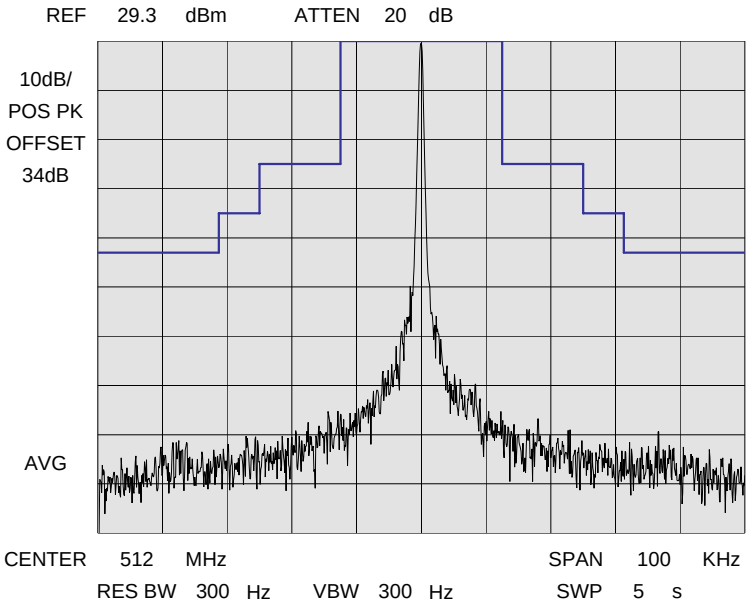
Power: Low
Modulation: None
25 kHz, MASK B



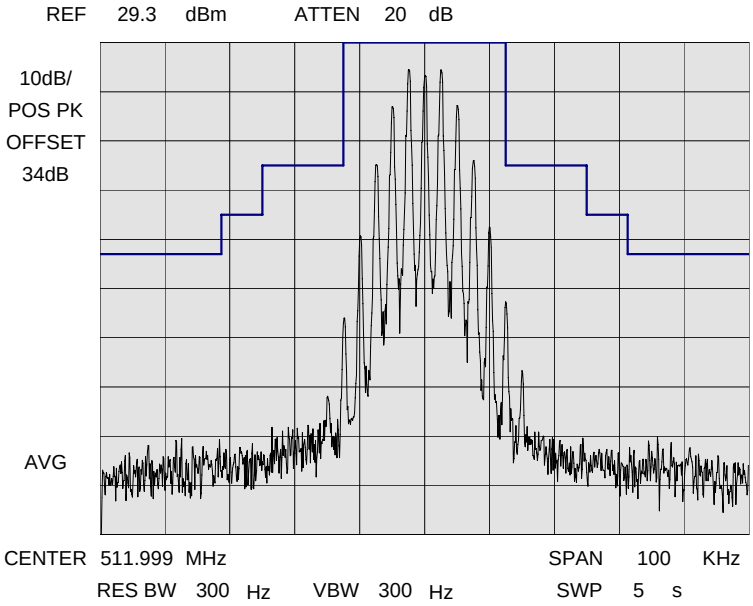
Power: Low
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



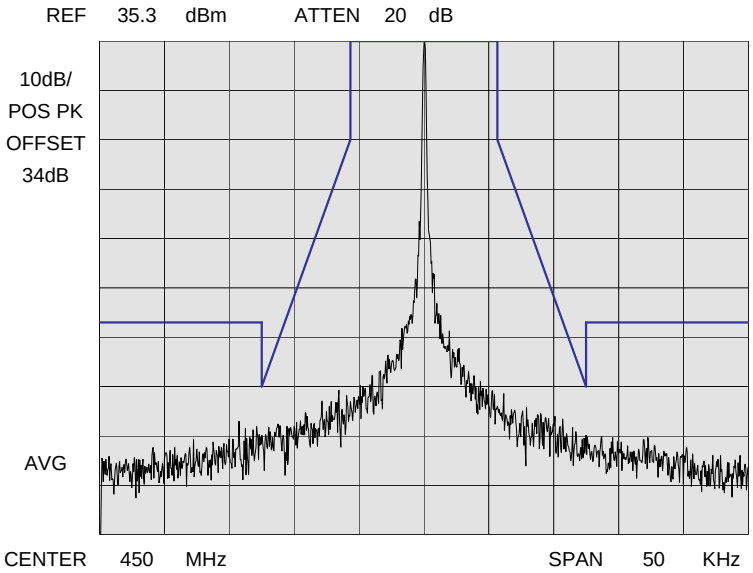
Power: Low
Modulation: None
25 kHz, MASK B



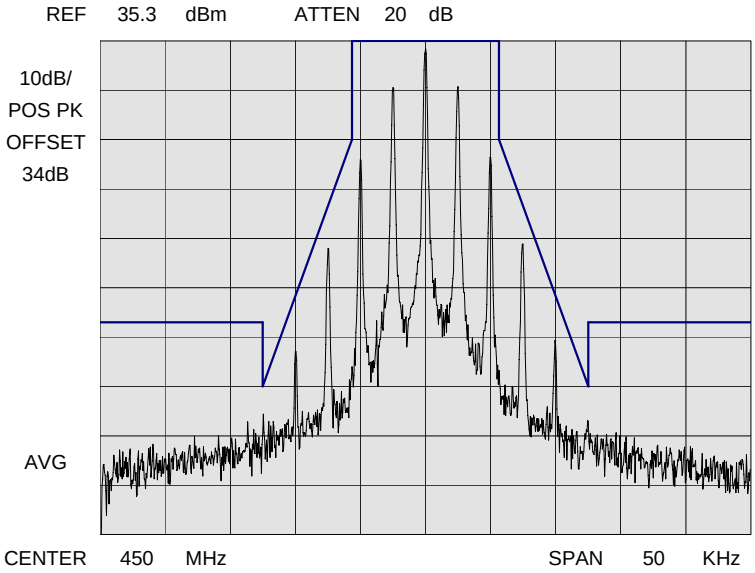
Power: Low
Modulation: Voice
25 kHz, MASK B

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



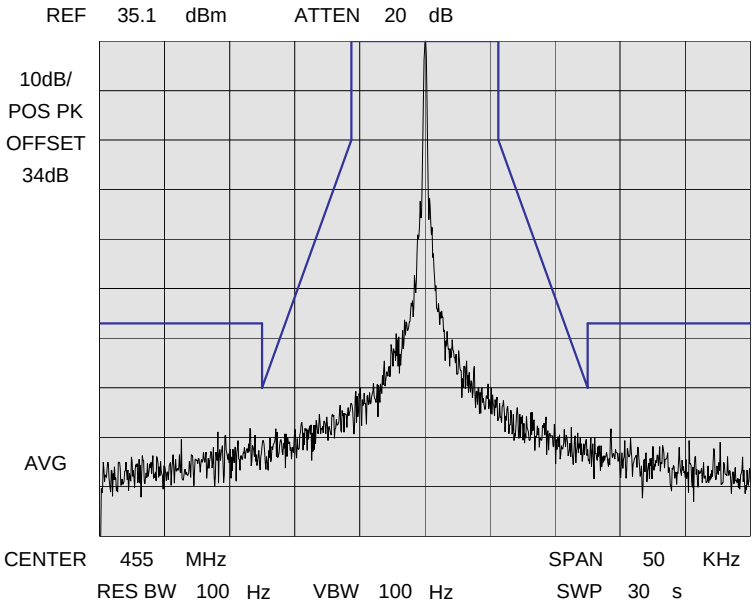
Power: High
Modulation: None
13 kHz, MASK D



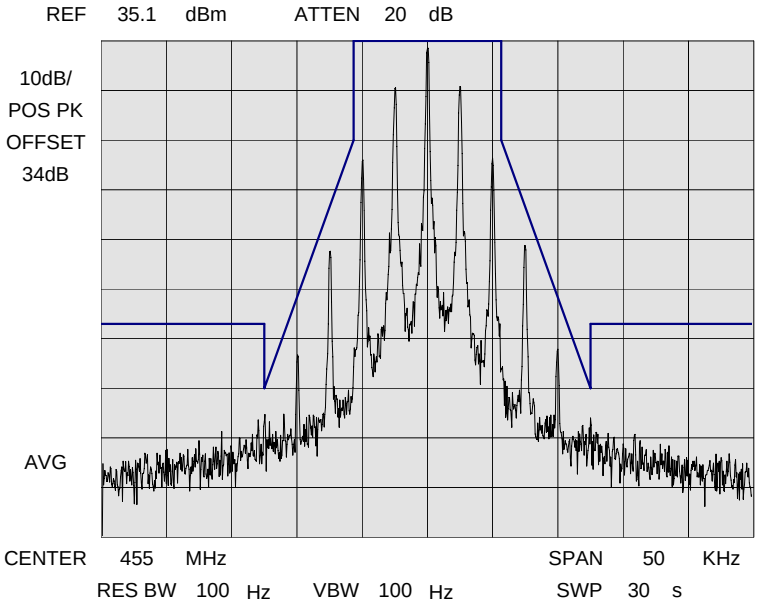
Power: High
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



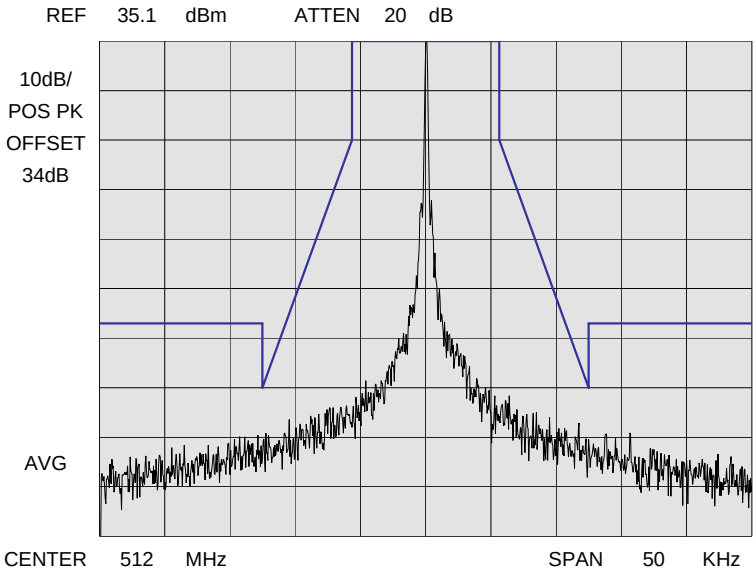
Power: High
Modulation: None
13 kHz, MASK D



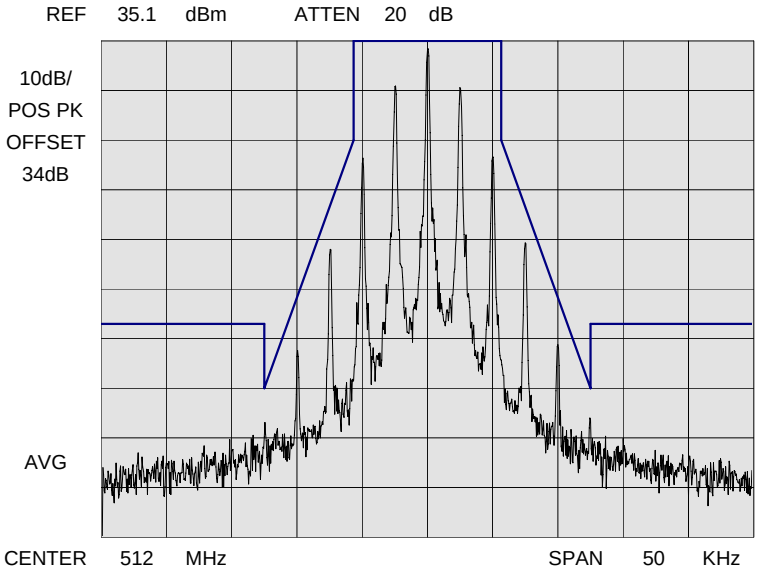
Power: High
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power



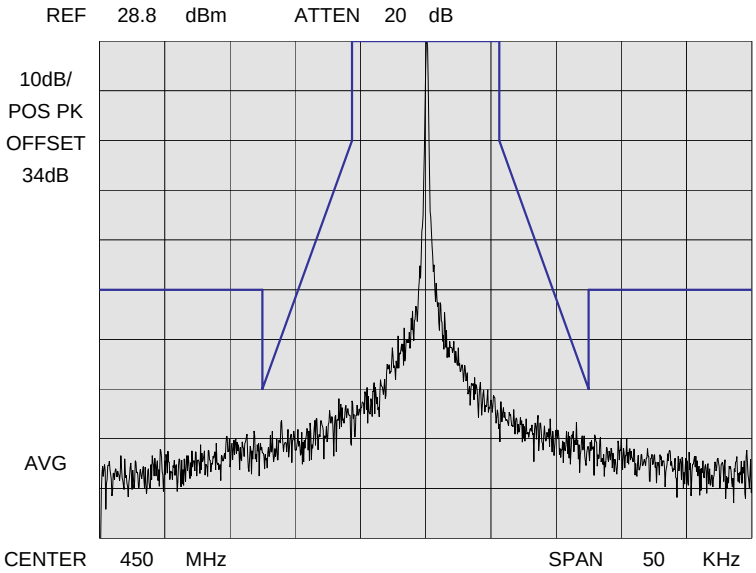
Power: High
Modulation: None
13 kHz, MASK D



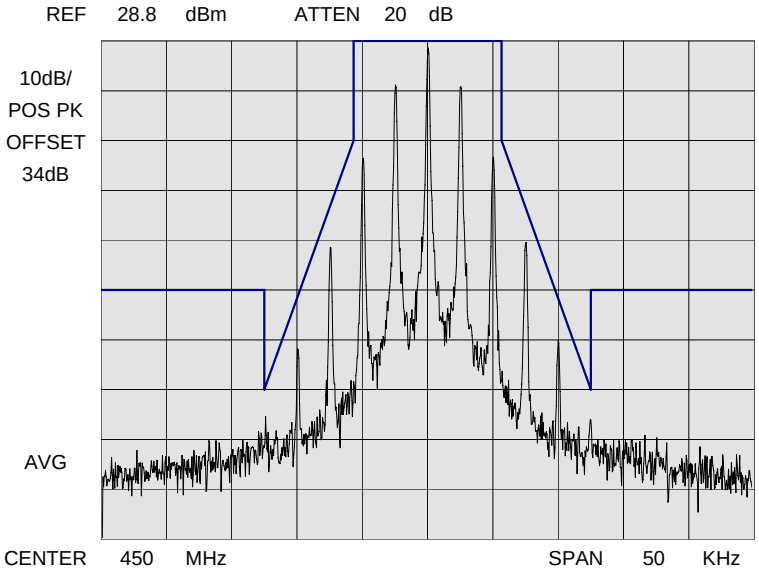
Power: High
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



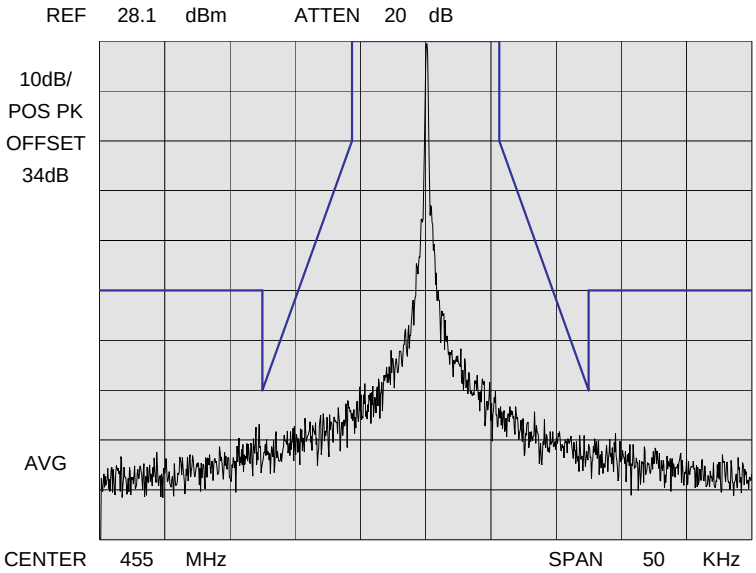
Power: Low
Modulation: None
13 kHz, MASK D



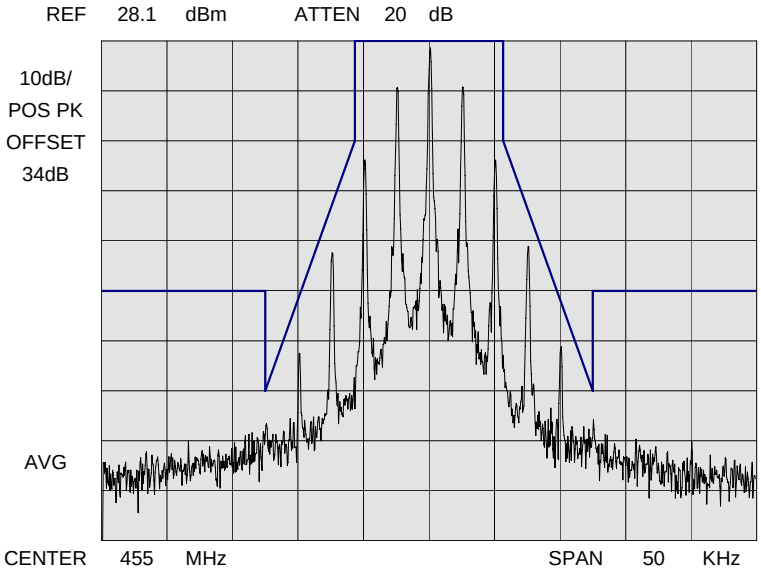
Power: Low
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



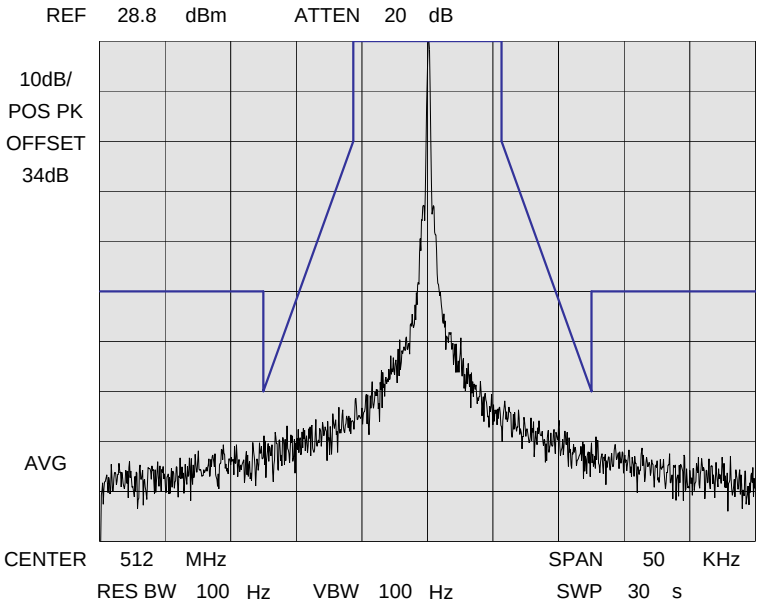
Power: Low
Modulation: None
13 kHz, MASK D



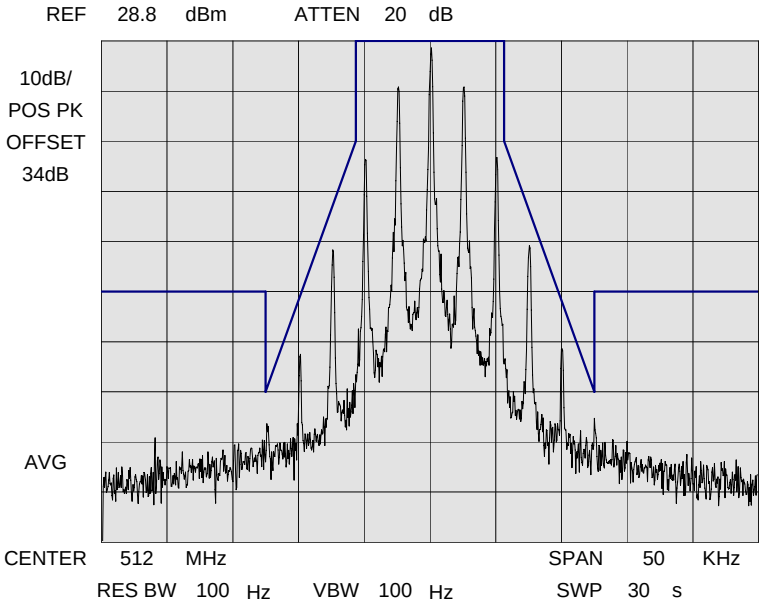
Power: Low
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power



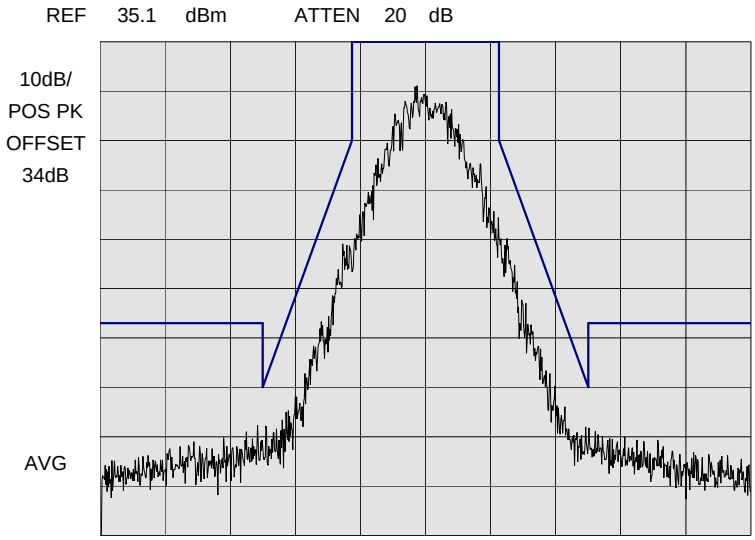
Power: Low
Modulation: None
13 kHz, MASK D



Power: Low
Modulation: Voice
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power

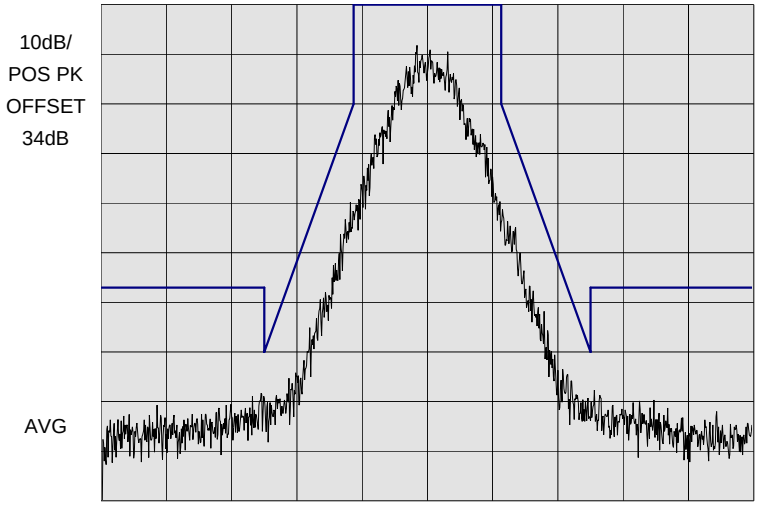


Power: High
Modulation: Digital
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power

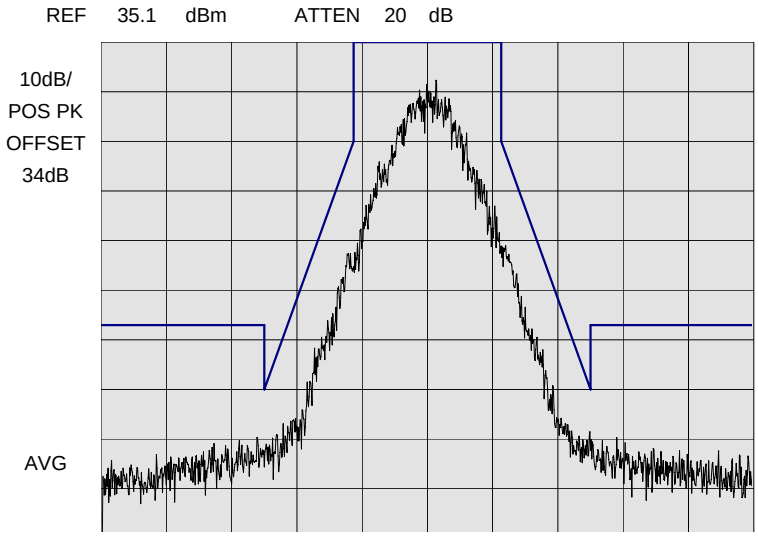
REF 35 dBm ATTEN 20 dB

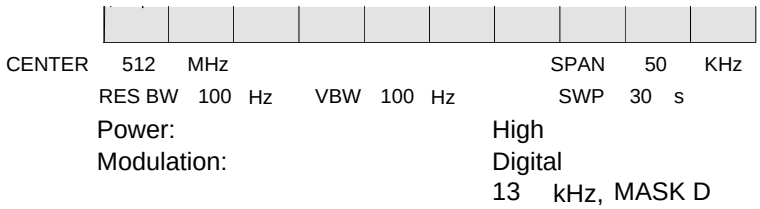


Power: High
Modulation: Digital
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 1 : High Power

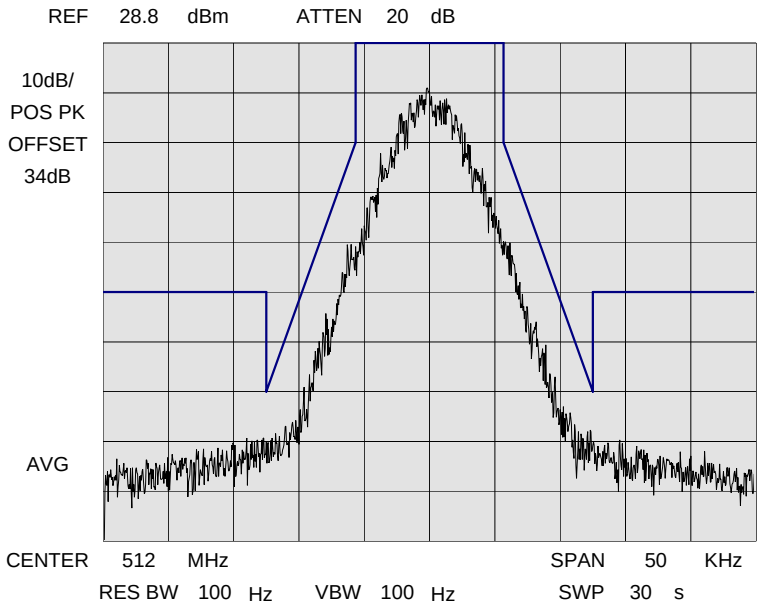




Power: High
Modulation: Digital
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

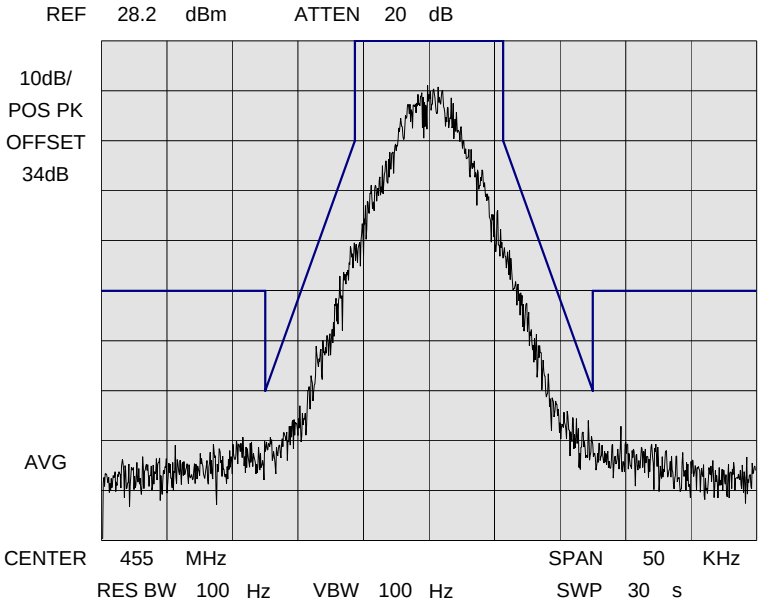
STATE: 2 : Low Power



Power: Low
Modulation: Digital
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

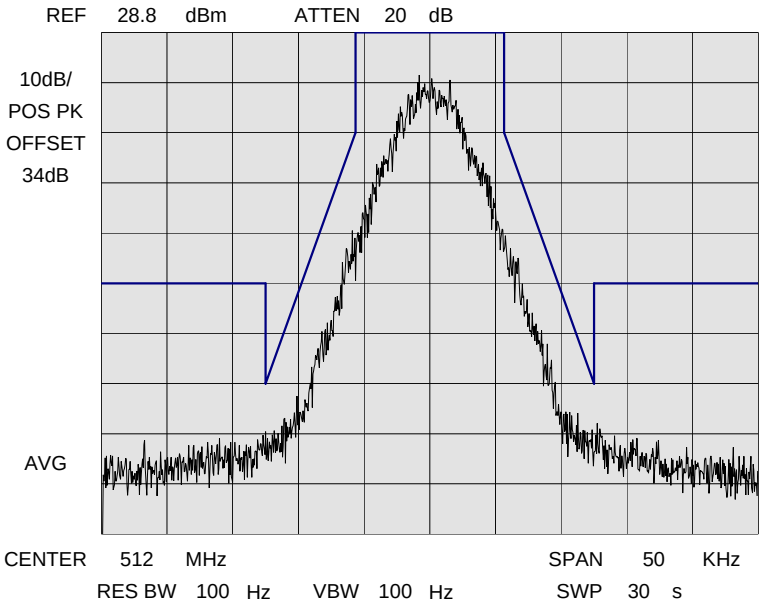
STATE: 2 : Low Power



Power: Low
Modulation: Digital
13 kHz, MASK D

NAME OF TEST: Emission Masks (Occupied Bandwidth)

STATE: 2 : Low Power

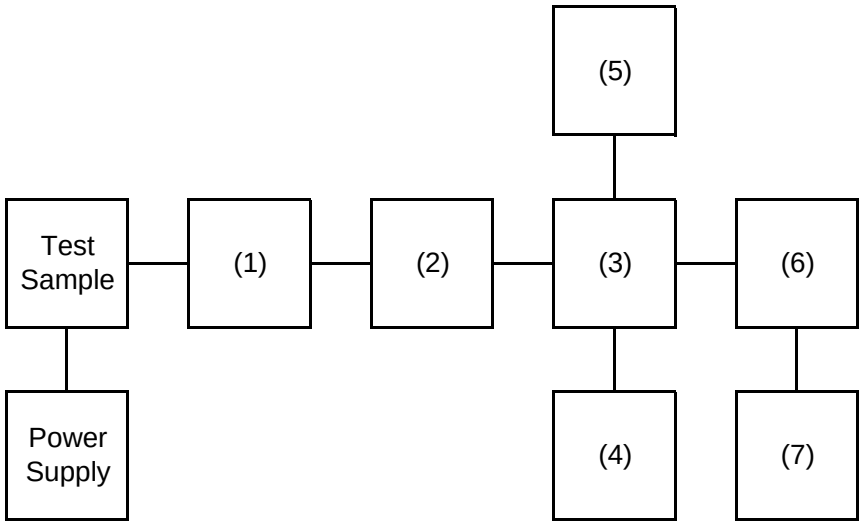


Power: Low

Modulation: Digital

13 kHz, MASK D

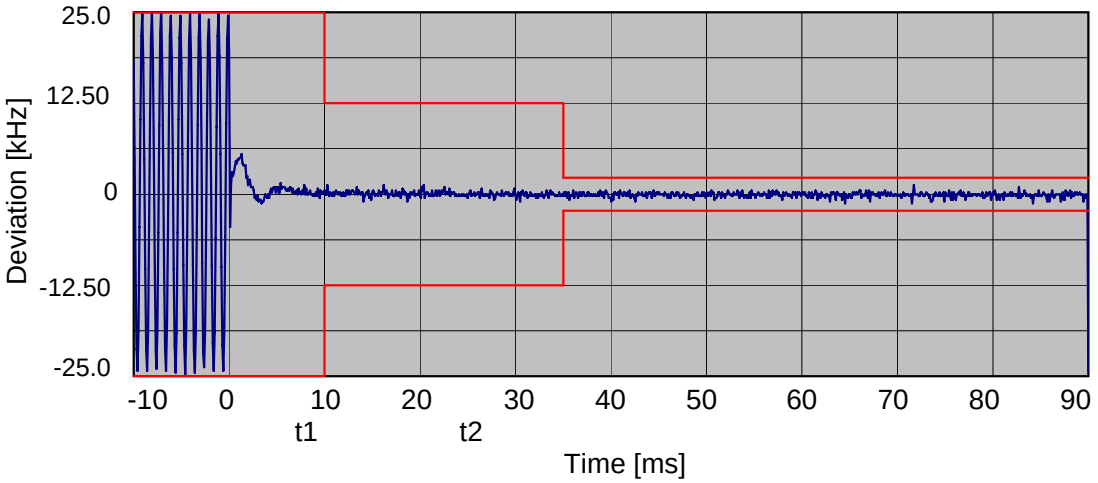
TRANSIENT FREQUENCY BEHAVIOR



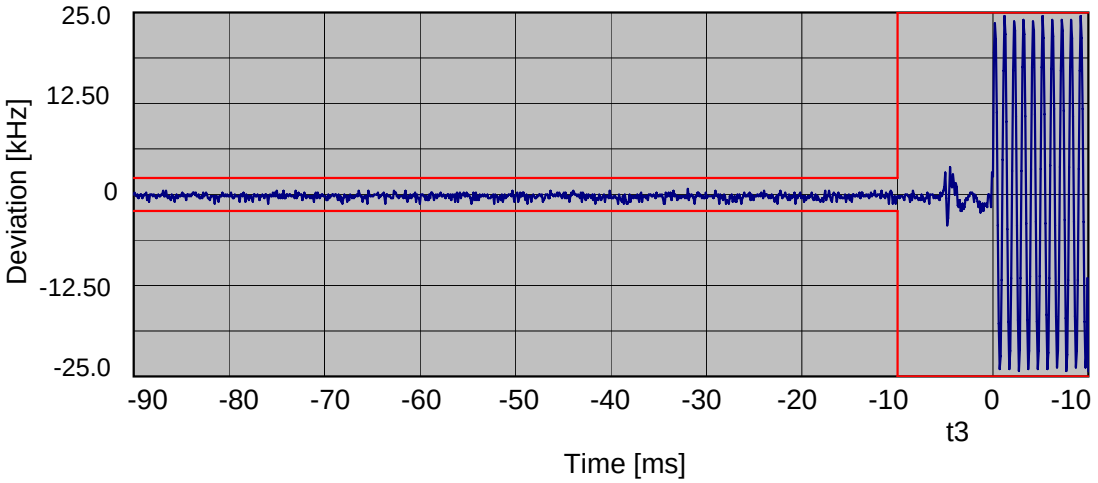
Instruments	Description	Serial Number
(1) COAXUAL ATTENUATOR	WEINSCHELL 49-10-43	***
(2) COAXUAL ATTENUATOR	WEINSCHELL 49-10-43	***
(3) COMBINER	IWATSU B-504D	***
(4) CRYSTAL DETECTOR	Agilent 8470B	***
(5) RF SIGNAL GENERATOR	Agilent 8642B	***
(5) MODULATION ANALYZER	Agilent 8901B	***
(5) SCOPE	Agilent 54504A	***

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



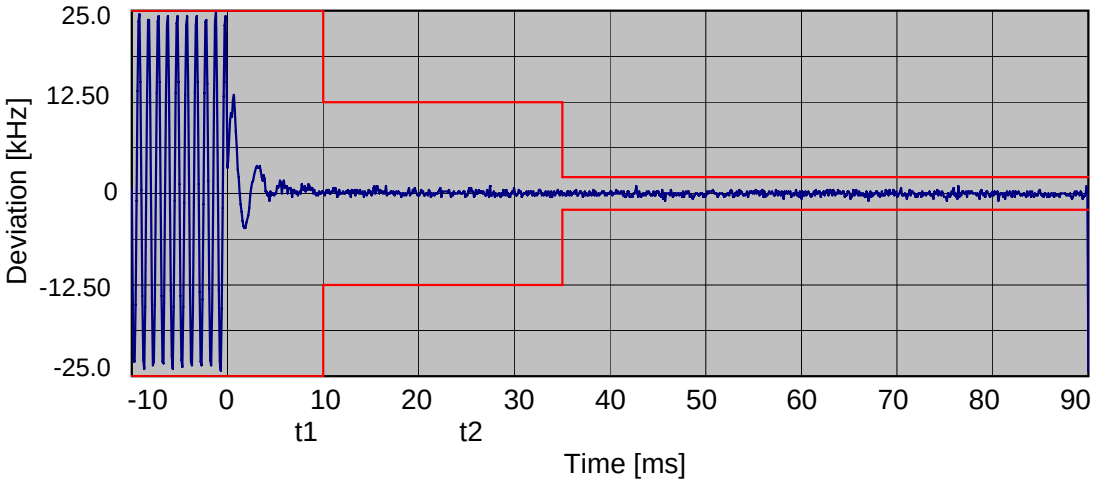
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	450		
Channel Spacing:	25	Ref. Standard	EIA



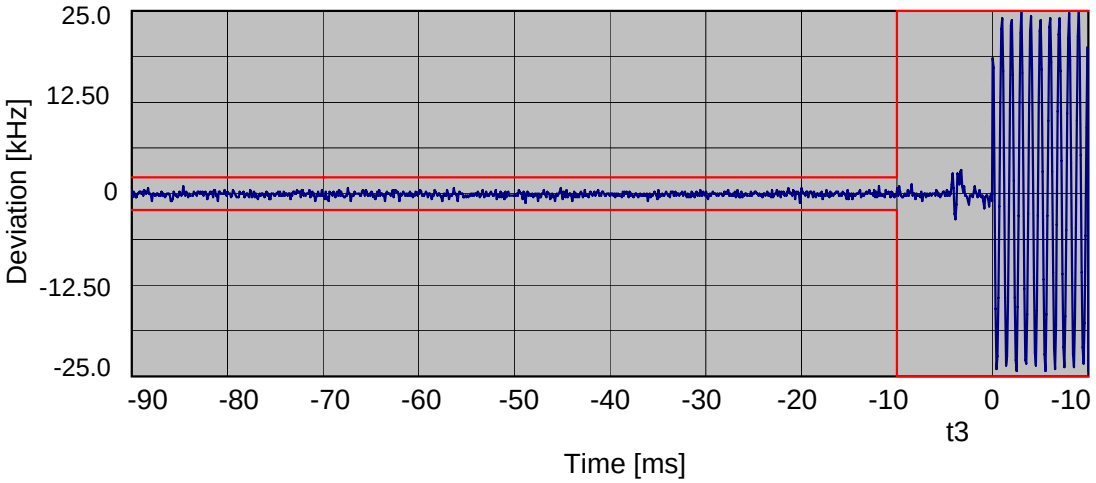
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	450		
Channel Spacing:	25	Ref. Standard	EIA

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



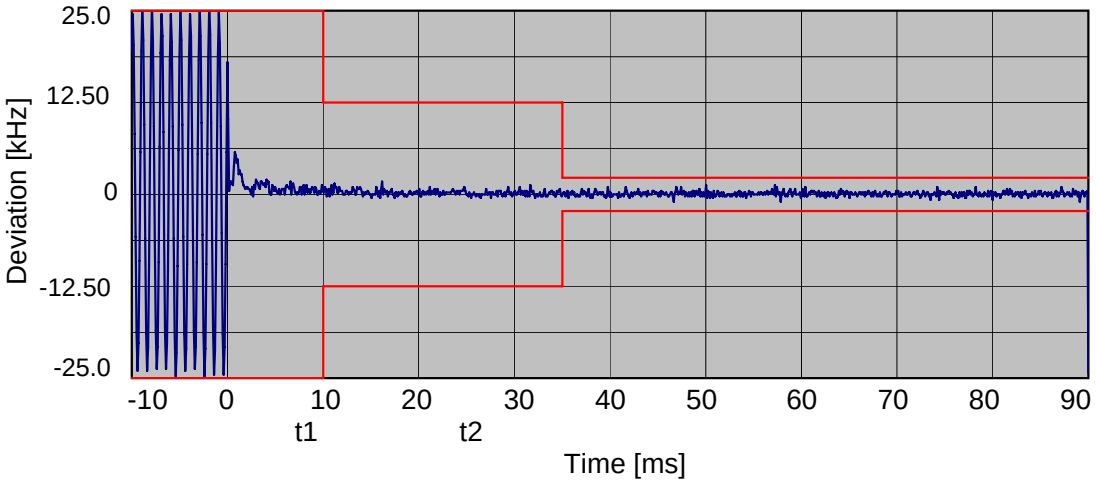
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	455		
Channel Spacing:	25	Ref. Standard	EIA



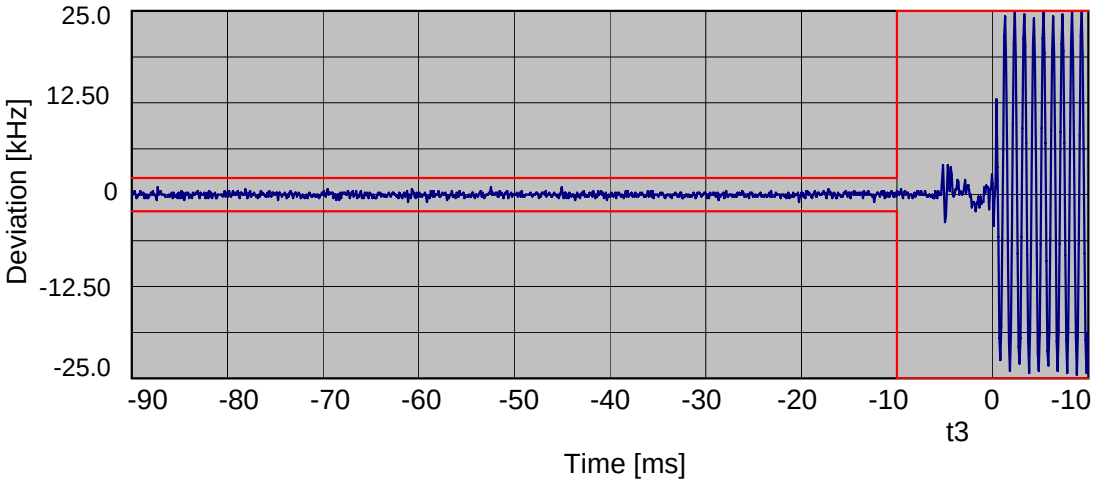
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	455		
Channel Spacing:	25	Ref. Standard	EIA

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



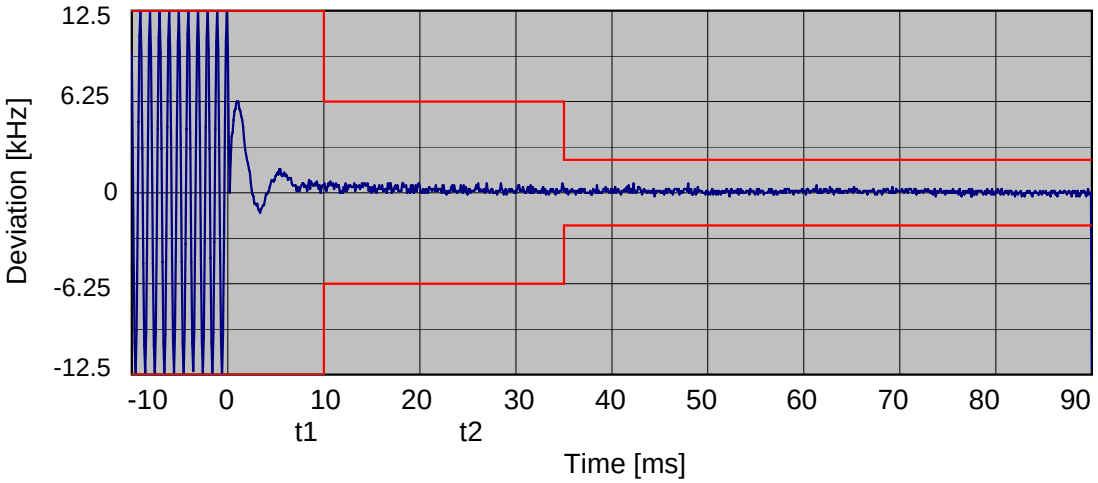
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	512		
Channel Spacing:	25	Ref. Standard	EIA



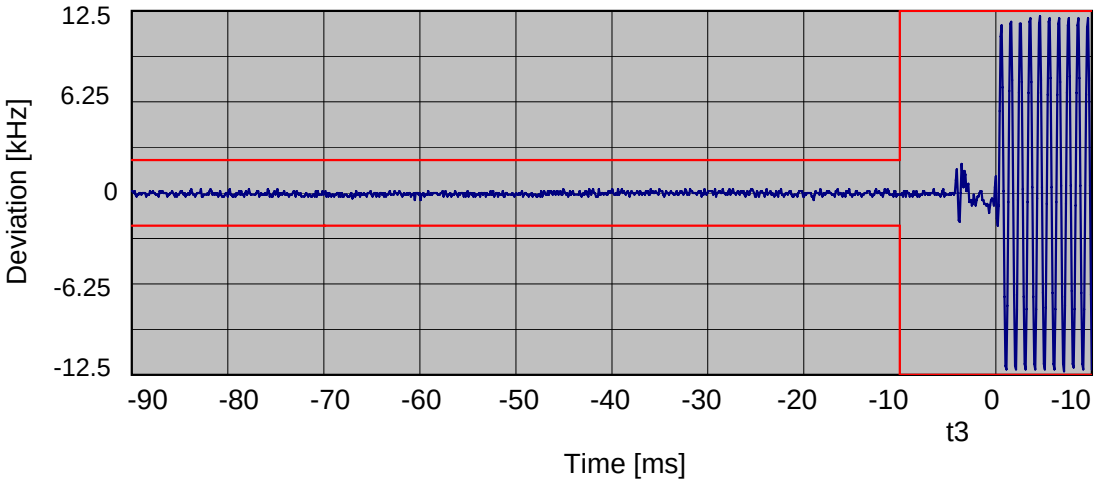
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	512		
Channel Spacing:	25	Ref. Standard	EIA

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



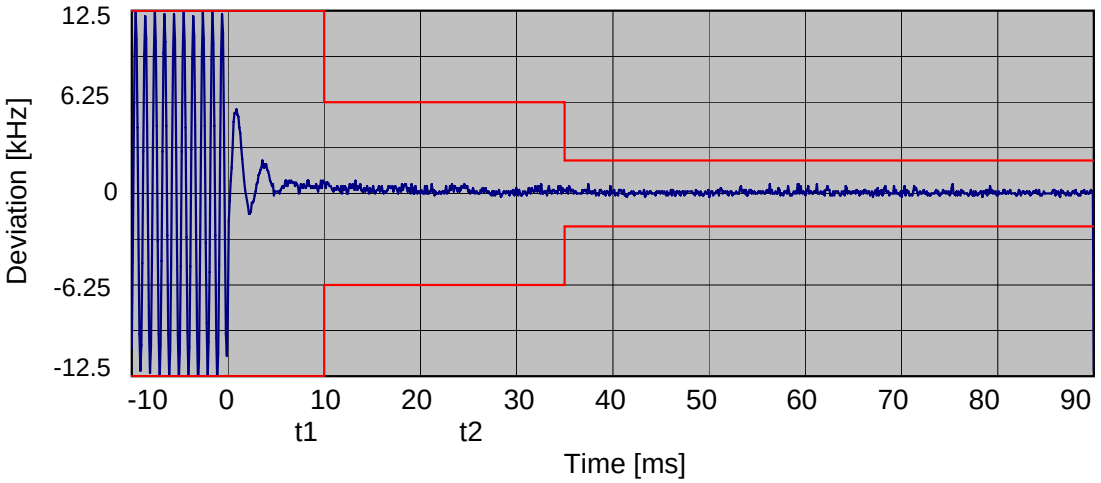
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	450		
Channel Spacing:	12.5	Ref. Standard	EIA



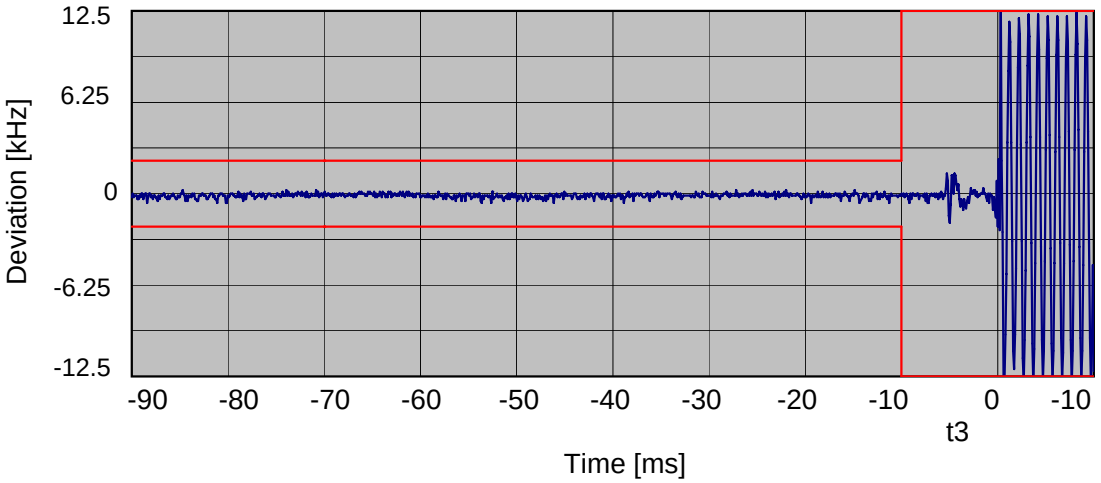
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	450		
Channel Spacing:	12.5	Ref. Standard	EIA

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



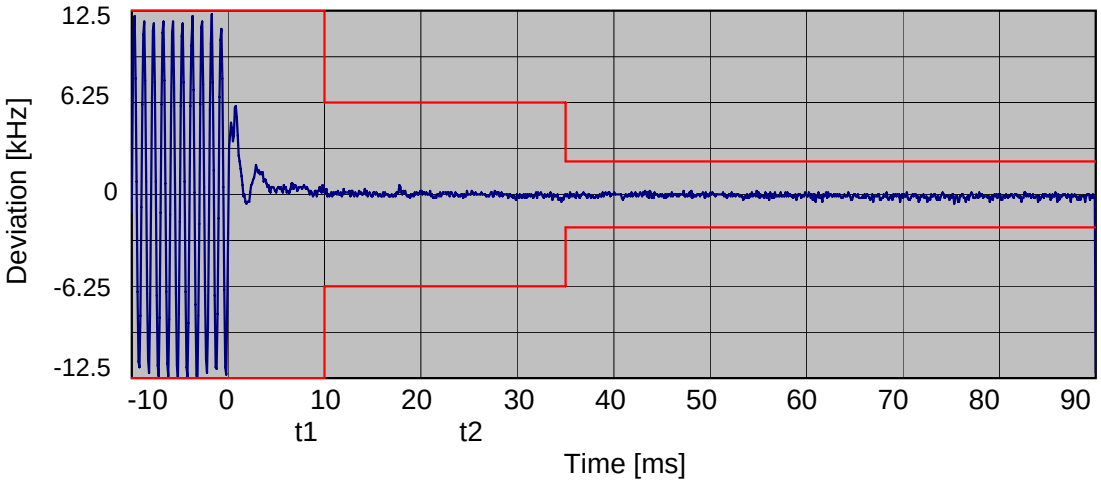
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	455		
Channel Spacing:	12.5	Ref. Standard	EIA



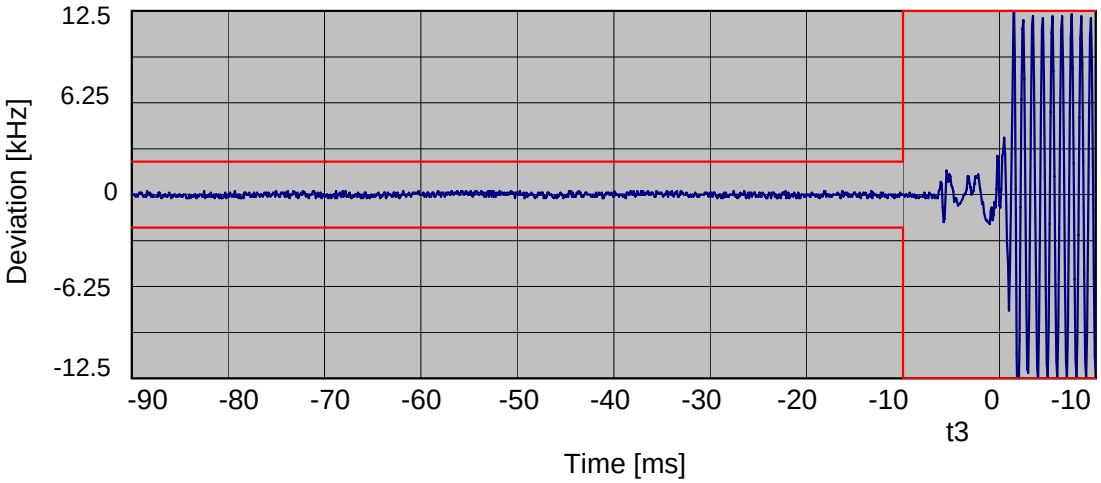
Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	455		
Channel Spacing:	12.5	Ref. Standard	EIA

NAME OF TEST: Transient Frequency Behaviour

STATE: 1 : High Power



Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Rise
Test Frequency:	512		
Channel Spacing:	12.5	Ref. Standard	EIA



Model Name:	VX-P829-G7-5	Type:	Mobile/Portable
Serial Number:	6N000007	Trigger Direction:	Fall
Test Frequency:	512		
Channel Spacing:	12.5	Ref. Standard	EIA

NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047 (a)
GUIDE: ANSI/TIA/EIA-603, Paragraph 2.2.15
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

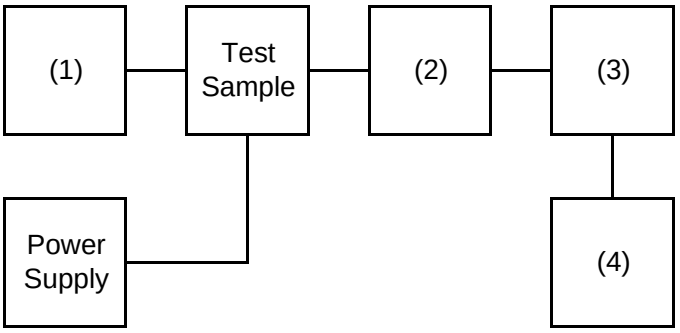
1. The EUT and test equipment ware set up such that the audio input was connecte at the input of the modulation limiter, and the modulated stage.

2. The audio output was connected at the output to the modulated stage.

3. MEASUREMENT RESULTS:ATTACHED

TRANSMITTER TEST SET-UP

TEST A: MODULATION CAPABILITY / DISTORTION
TEST B: AUDIO FREQUENCY RESPONSE
TEST C: HUM AND NOISE LEVEL
TEST D: RESPONSE OF LOW PASS FILTER
TEST E: MODULATION KIMITING

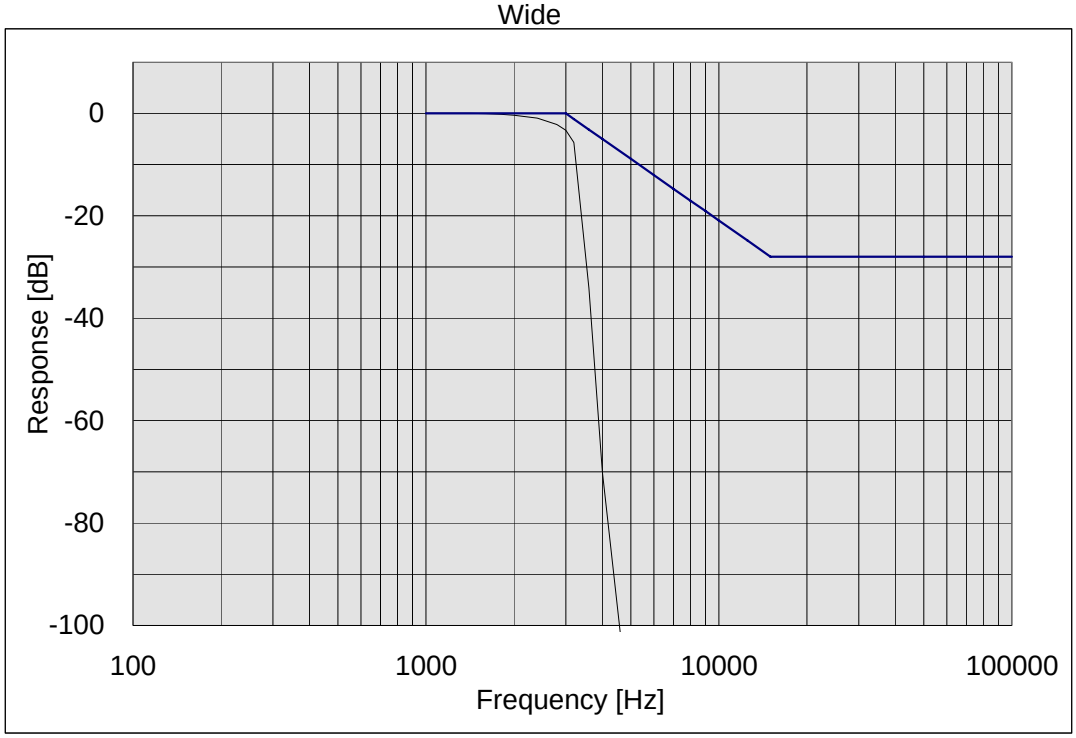


Instruments	Description	Serial Number
(1) AUDIO GENERATOR	Agilent 8903B	***
(2) COAXIAL ATTENUATOR	Agilent 8498A	***
(3) MODULATION ANALYZER	Agilent 8901B	***
(4) AUDIO ANALYZER	Agilent 8903B	***

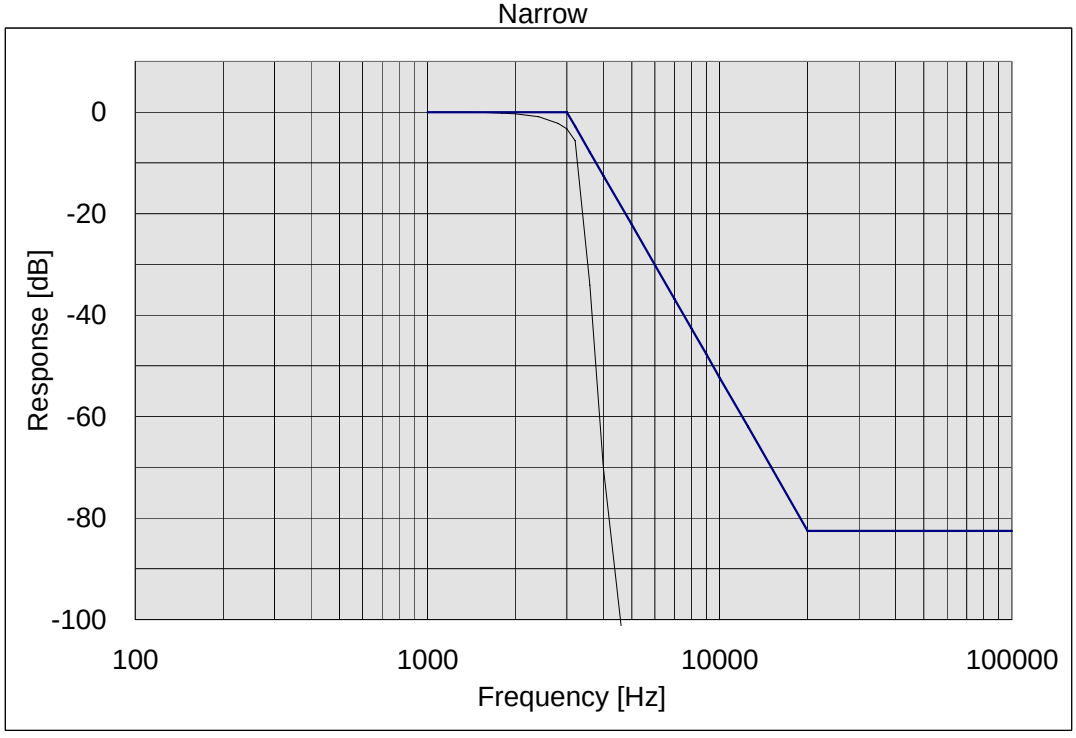
NAME OF TEST: Audio Low Pass Filter (Voice Input)

STATE: 0 : General

Wide



Narrow



NAME OF TEST:	Audio Frequency Response
SPECIFICATION:	47 CFR 2.1047 (a)
GUIDE:	ANSI/TIA/EIA-603, Paragraph 2.2.6
TEST EQUIPMENT:	As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment ware set up as shown on the following page

2. The audio signal generator was connected to the audio input circuit/microphone o the EUT.

3. The audio signal input was adjusted to obtain 20% modulation at 1kHz, and this p was taken as the 0dB reference level.

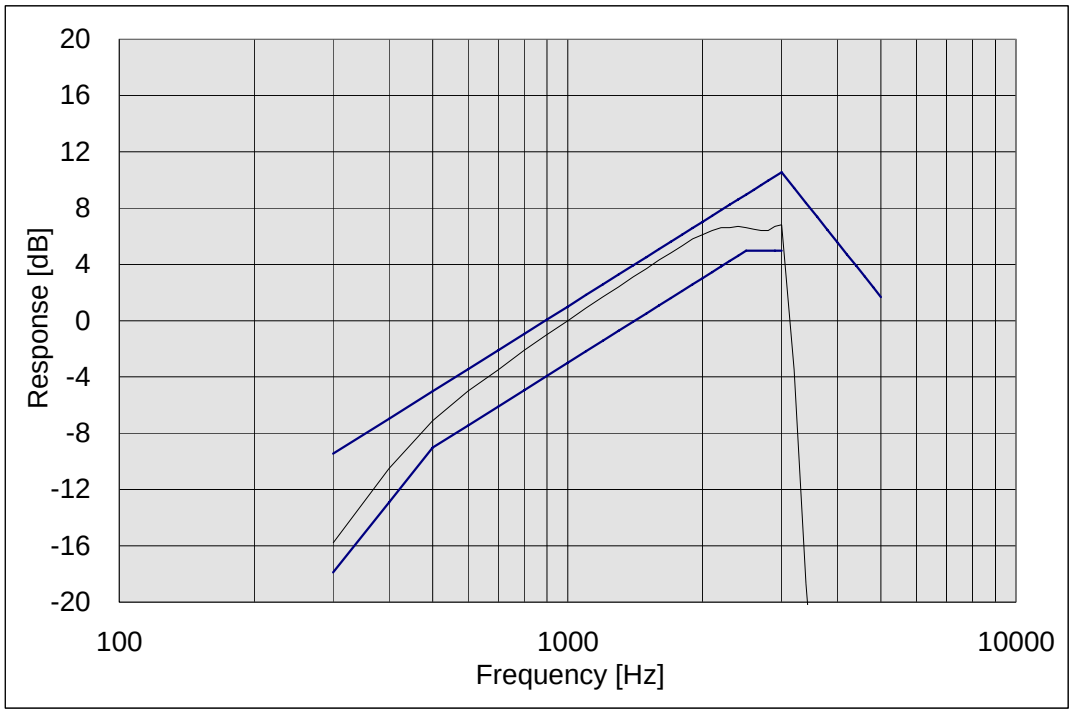
4. Which input levels hold constant and below limiting at all frequencies, the audic signal generator was varied from 100Hz to 5kHz.

5. The response in dB relative to 1kHz was then measured, using the Agilent 8901E modulation analyzer.

6. MEASUREMENT RESULTS:ATTACHED

NAME OF TEST: Audio Frequency Response

STATE: 0 : General



PEAK AUDIO FREQUENCY : 3000 [Hz]

NAME OF TEST: Modulation Limiting
SPECIFICATION: 47 CFR 2.1047 (b)
GUIDE: ANSI/TIA/EIA-603, Paragraph 2.2.3
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The signal generator was connected to the input of the EUT as for "Frequency Response of the Modulating Circuit".

2. The modulation response was measured for each of three frequencies (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an Agilent 8901B modulation analyzer

3. The input level was varied from 30% modulation (± 1.5kHz deviation) to at least 20dB higher than the saturation point.

4. Measurements ware performed for both negative and positive modulation and the respective results ware recorded.

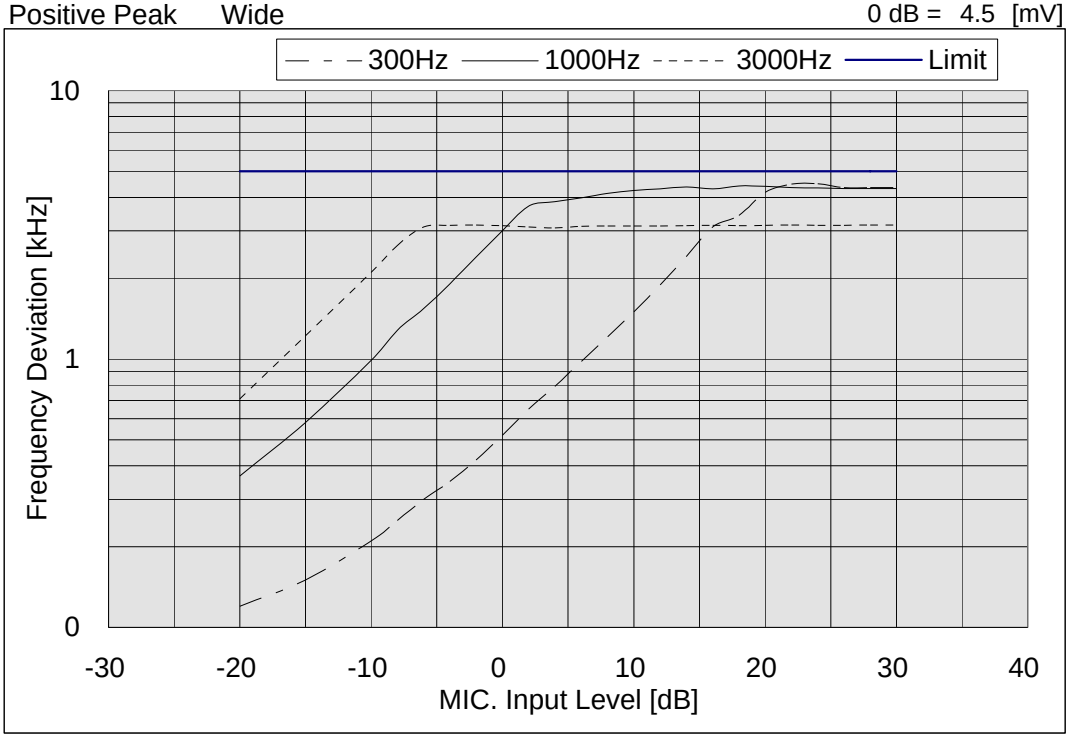
5. MEASUREMENT RESULTS:ATTACHED

NAME OF TEST: Modulation Limiting

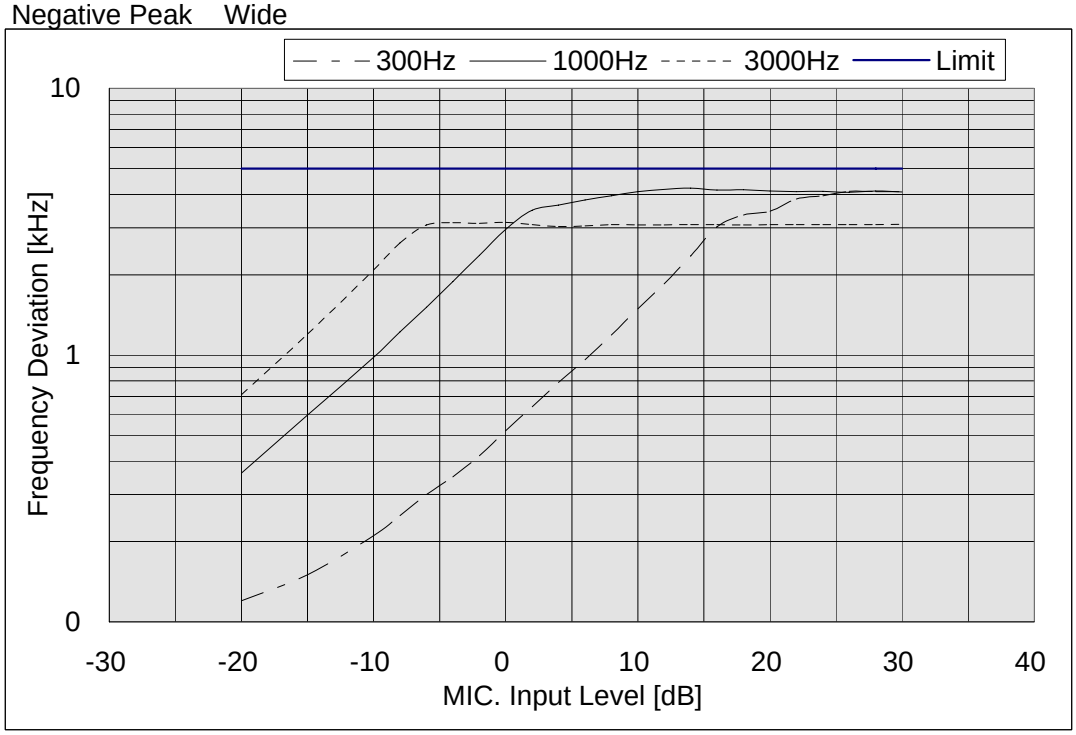
STATE: 0 : General

Positive Peak Wide

0 dB = 4.5 [mV]



Negative Peak Wide

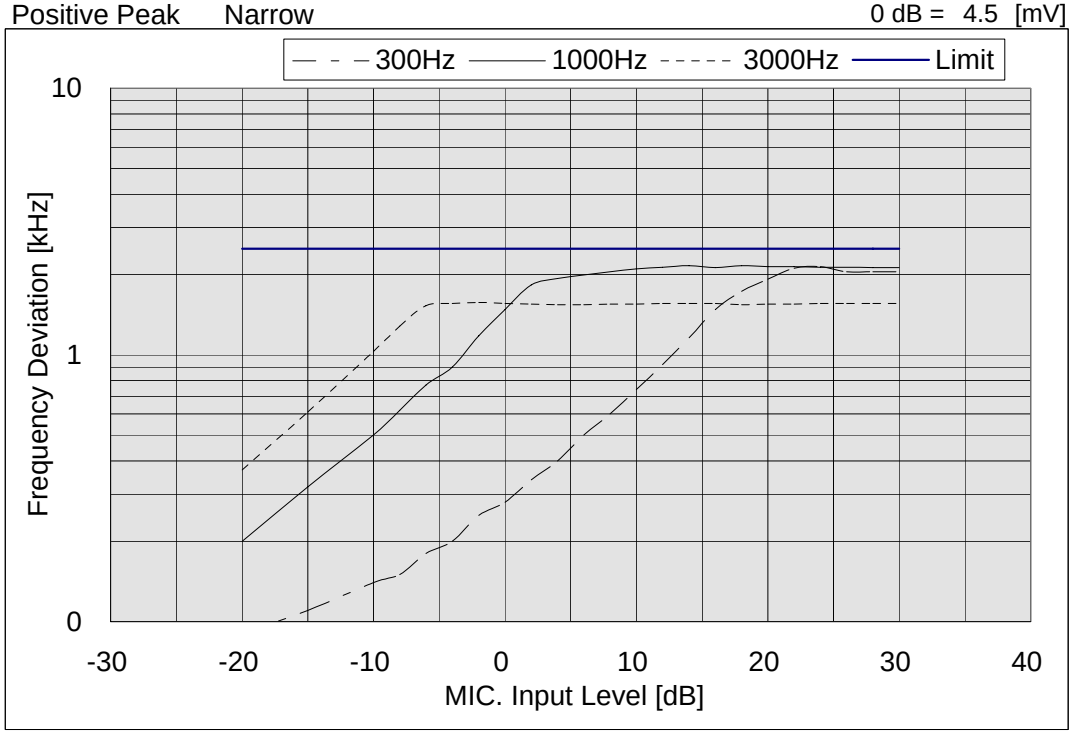


NAME OF TEST: Modulation Limiting

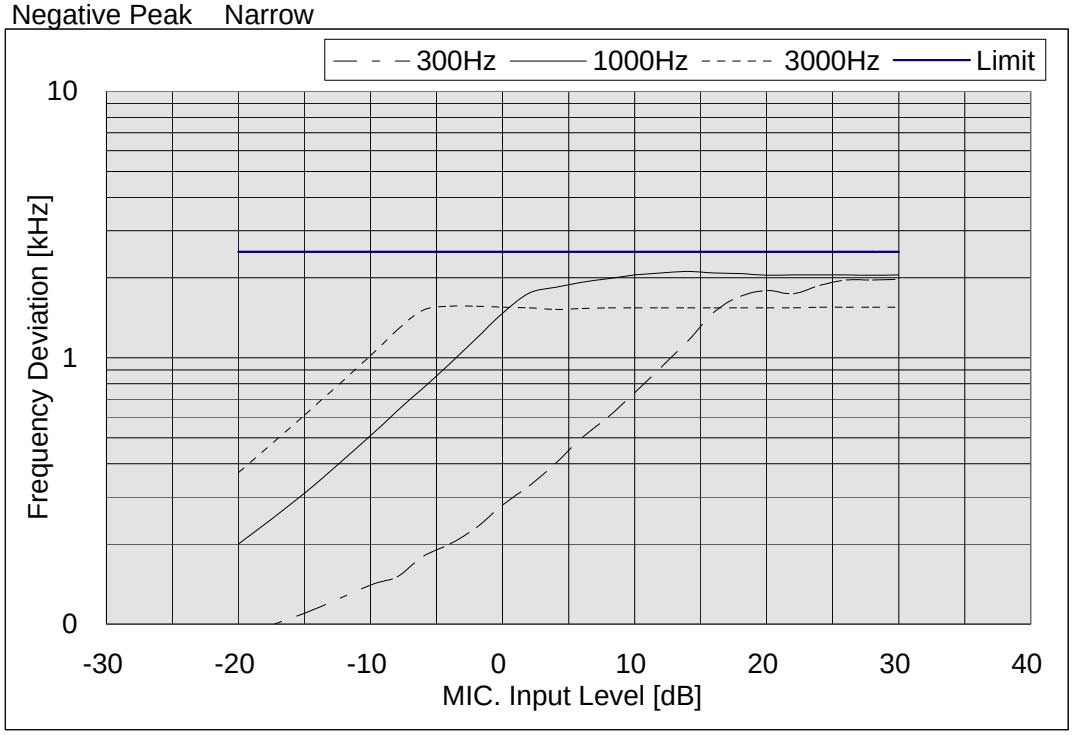
STATE: 0 : General

Positive Peak Narrow

0 dB = 4.5 [mV]



Negative Peak Narrow



NAME OF TEST:	Frequency Stability (Temperature Variation)
SPECIFICATION:	47 CFR 2.1055 (a) (1)
GUIDE:	ANSI/TIA/EIA-603, Paragraph 2.2.2
TEST CONDITIONS:	As indicated
TEST EQUIPMENT:	As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment ware set up as shown on the following page

2. With all power removed, the temperature was decreased to -30℃ and permitted to stabilize for three hours. Power was applied and themaximum change in frequency was noted within one minute.

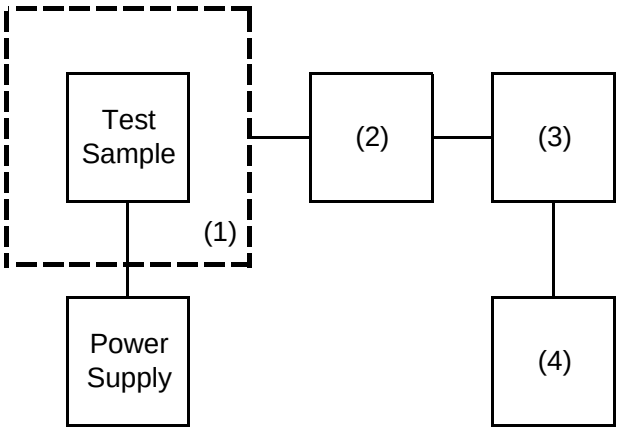
3. With power OFF, the temperature was raised in 10℃ steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.

4. The temperature tests ware performed for the worst case.

5. MEASUREMENT RESULTS:ATTACHED

TRANSMITTER TEST SET-UP

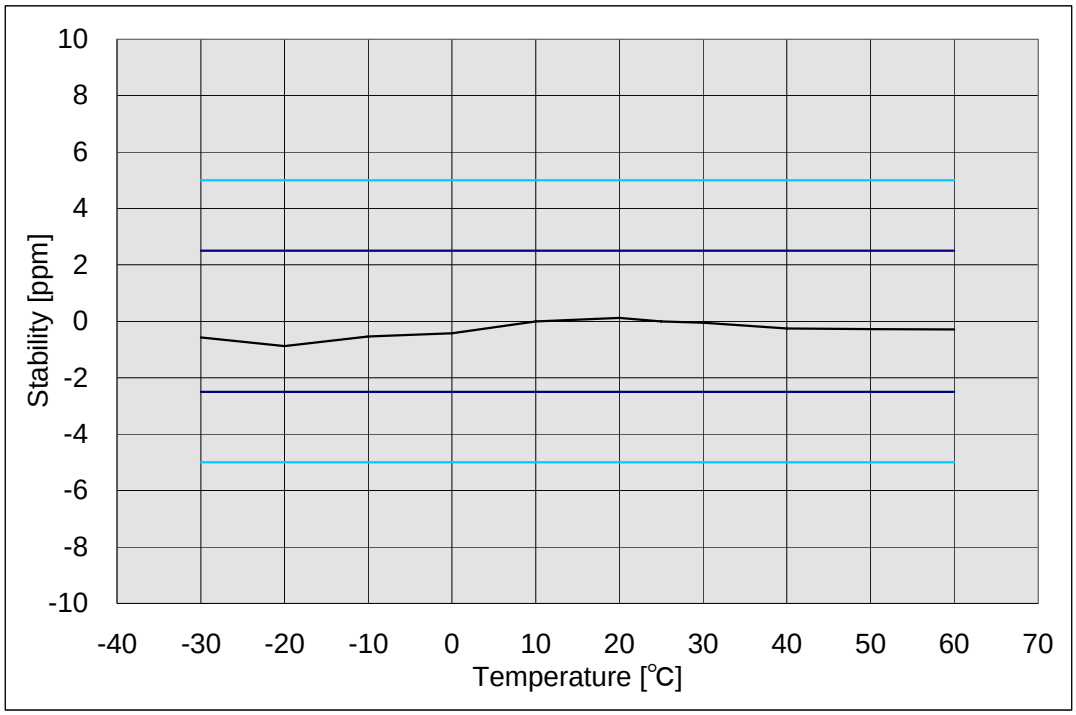
TEST A: OPERATIONAL STABILITY
TEST B: CARRIER FREQUENCY STABILITY
TEST C: OPERATIONAL PERFORMANCE STABILITY
TEST D: HUMIDITY
TEST E: VIBRATION
TEST F: ENVIRONMENTAL TEMPERATURE
TEST G: FREQUENCY STABILITY, TEMPERATURE VARIATION
TEST H: FREQUENCY STABILITY, VOLTAGE VARIATION



Instruments	Description	Serial Number
(1) TEMPERATURE CHAMBEI	ETAC FX4100	***
(2) COAXIAL ATTENUATOR	Weinschel 53-30-33	***
(3) POWER METER	Agilent 436A	***
(4) FREQUENCY COUNTER	gilent 8901B FREQUENCY MOI	***

NAME OF TEST: Frequency Stability (Temperature Variation)

STATE: 0 : General



NAME OF TEST: Frequency Stability (Voltage Variation)
SPECIFICATION: 47 CFR 2.1055 (b)
GUIDE: ANSI/TIA/EIA-603, Paragraph 2.2.2
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at 25±5℃ and connected as for "Frequency Stability - Temperature Variation" test.

2. The power supply voltage to the EUT was varied from 85% to 115% of the nomina value measured at the input to the EUT.

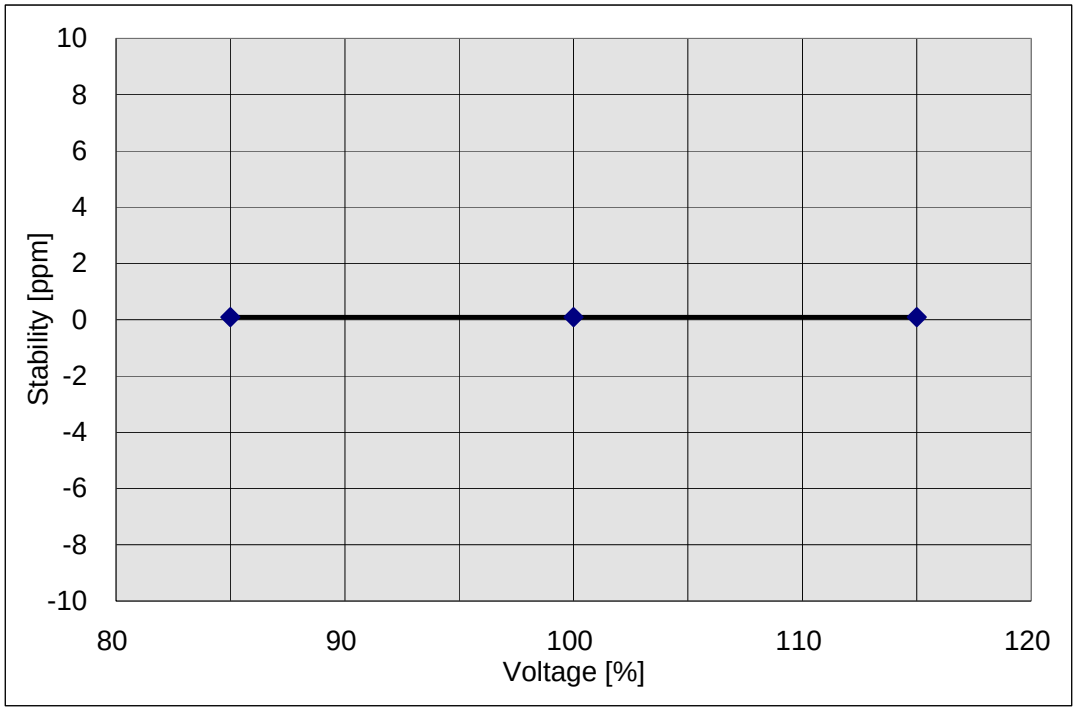
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)

STATE: 0 : General

LIMIT', ppm = 2.5
LIMIT', Hz = 1138

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	6.29	455.000040	40	0.09
100	7.40	455.000040	40	0.09
115	8.51	455.000040	40	0.09



NAME OF TEST: Necessary Bandwidth and Emission Bandwidth
SPECIFICATION: 47 CFR 2.202 (g)

MODULATION = 16K0F3E

NECESSARY BANDWIDTH CALUCULATION:

MAXIMUM MODULATION (M), kHz	=	3
MAXIMUM DEVIATION (D), kHz	=	5
CONSTANT FACTOR (K)	=	1
NECESSARY BANDWIDTH (BN), kH	=	(2xM) + (2xDxK)
	=	16

MODULATION = 11K0F3E

NECESSARY BANDWIDTH CALUCULATION:

MAXIMUM MODULATION (M), kHz	=	3
MAXIMUM DEVIATION (D), kHz	=	3
CONSTANT FACTOR (K)	=	1
NECESSARY BANDWIDTH (BN), kH	=	(2xM) + (2xDxK)
	=	11

NAME OF TEST: Receiver Spurious Emissions (Conducted)
STATE: 0 : General
All other emissions in the required measurement range ware mora than 20dB below the required limits.

MEASUREMENT RESULTS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, nW
400.000	349.150	-78.7	0.0130

NAME OF TEST: Receiver Spurious Emissions (Radiated)
STATE: 0 : General
All other emissions in the required measurement range ware mora than 20dB below the required limits.

MEASUREMENT RESULTS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBuV	@m	CF, dB	uV/m
450.000	399.150	24.7	3	-1.7	20.9
455.000	404.150	25.8	3	-4.3	32.0
512.000	461.150	29.4	3	-4.1	47.3